

Status attivita' Roma1 2010/2011

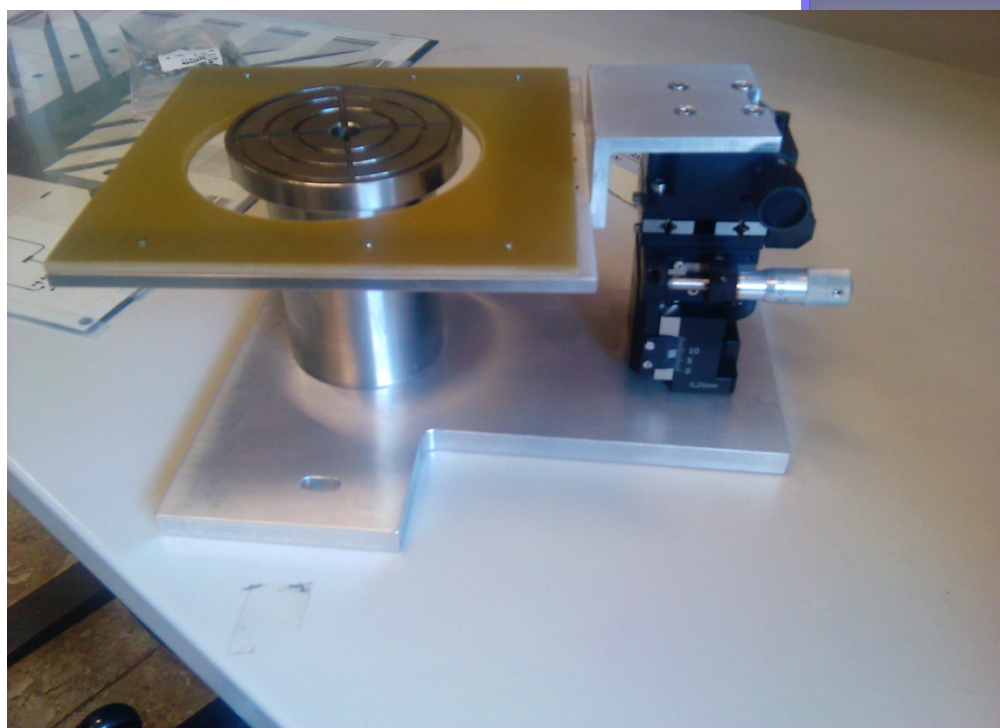
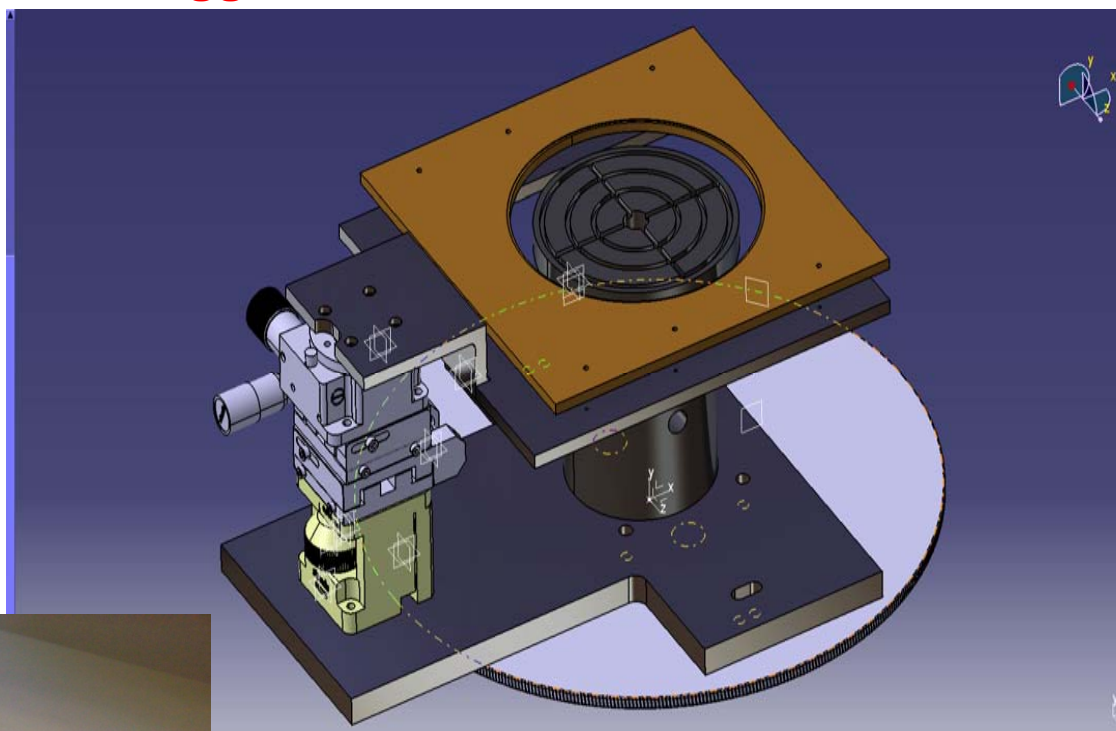
INDICE:

- **Attività per la “Camera Pulita”:**
 - a) Movimentazione micrometrica per
 - incollaggio
 - saldatura a ultrasuoni
 - b) Microscopio e sua movimentazione fine

- **PCB rigido (FR4) Multilayer per SiD**
 - Piano X
 - Piano Y
 - Simulazioni con scelta della geometria per massimizzare SNR

- **Elettronica di Front-End**
 - Test APV25

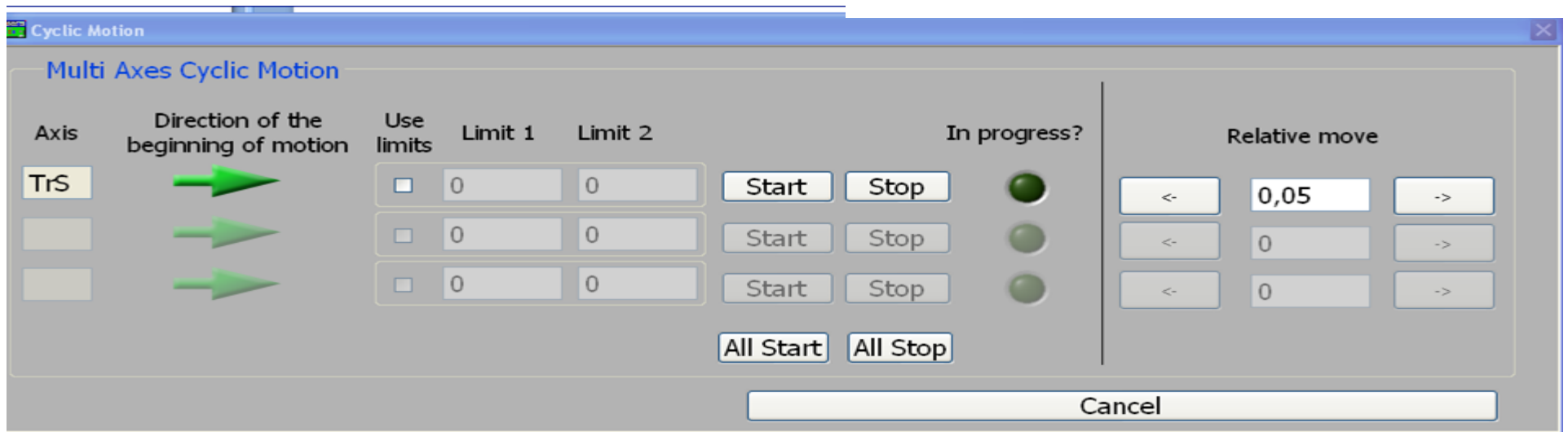
Movimentazione fine per prove di incollaggio



Movimentazione motorizzata per il wire-bonding



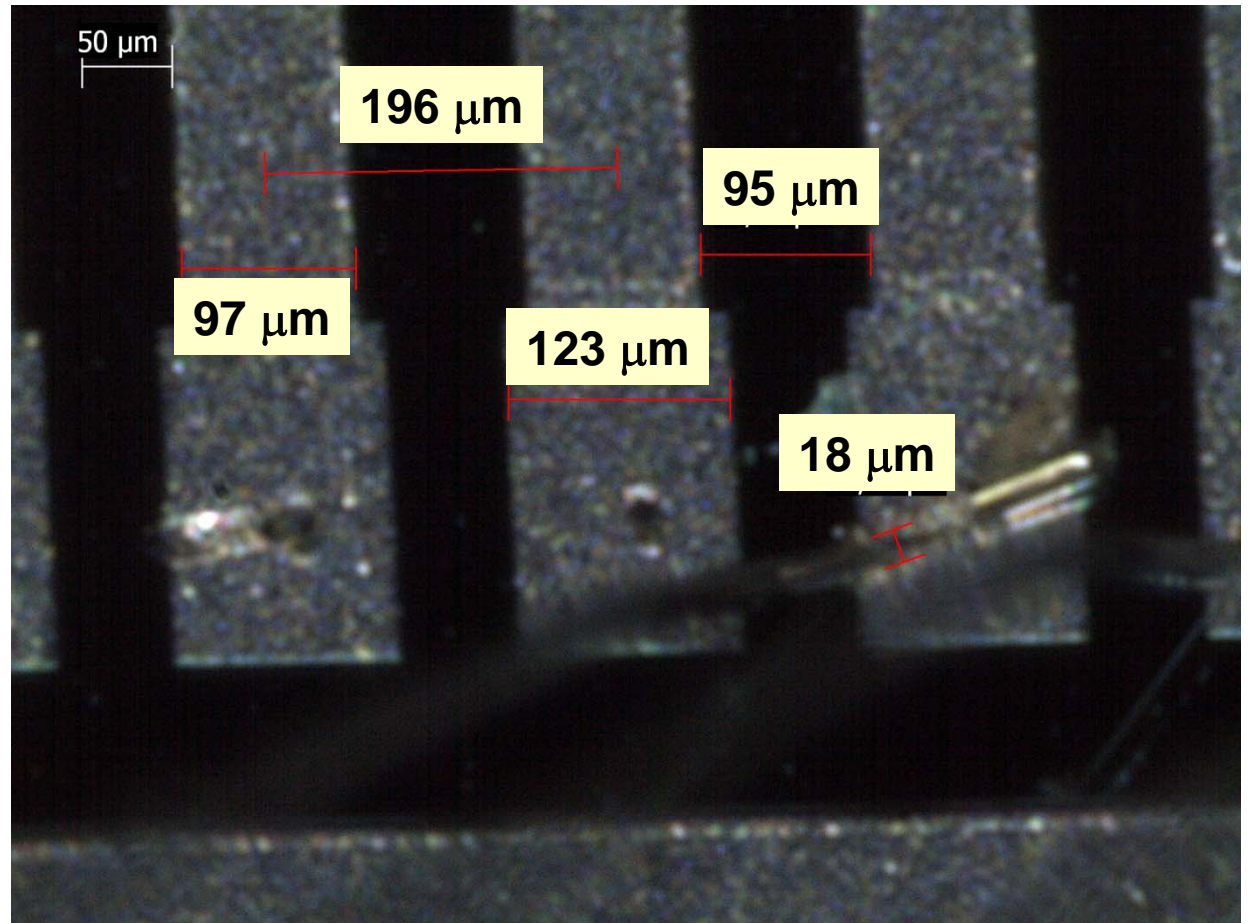
8MT175-150

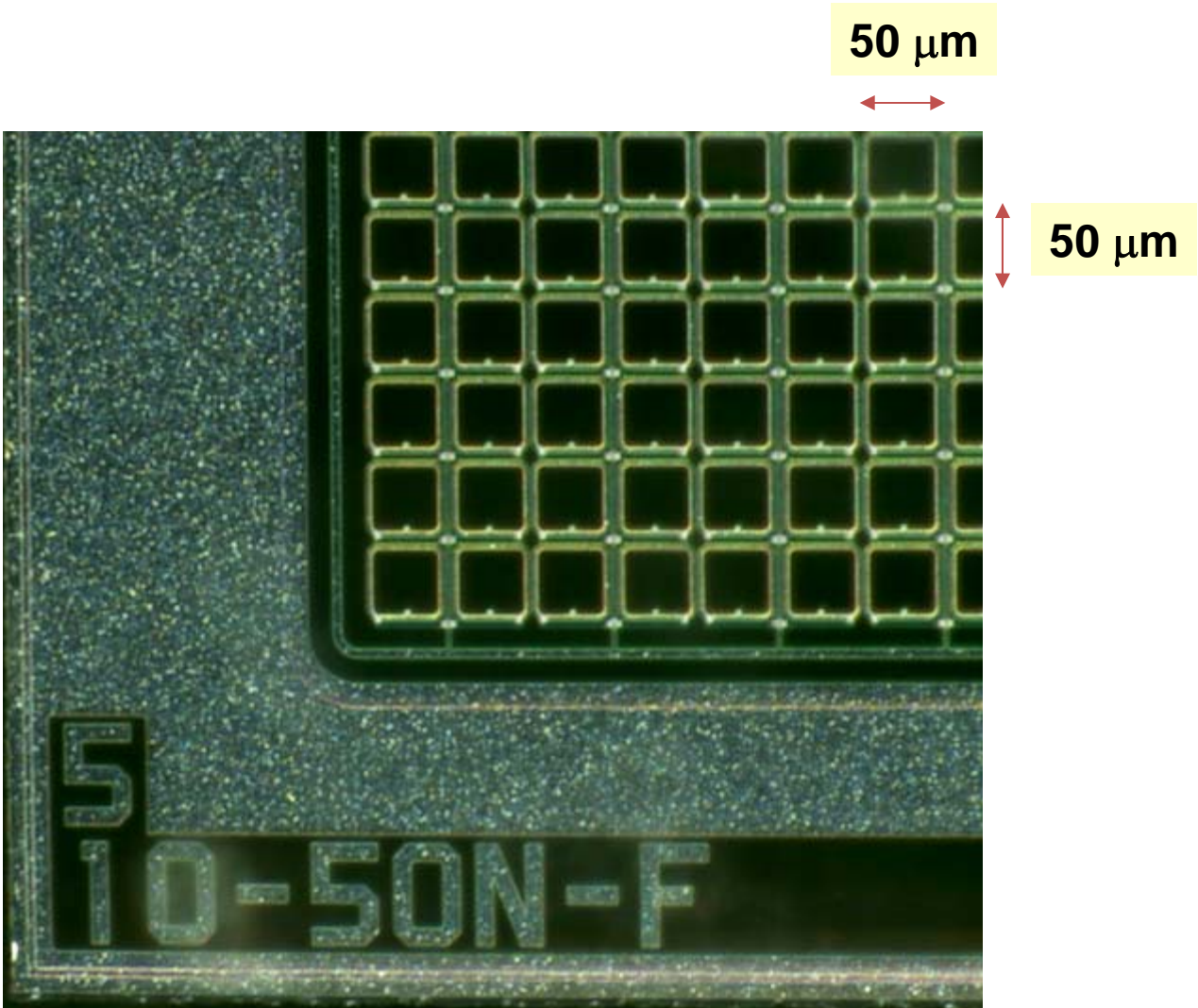


Microscopio Leica APO Z 16

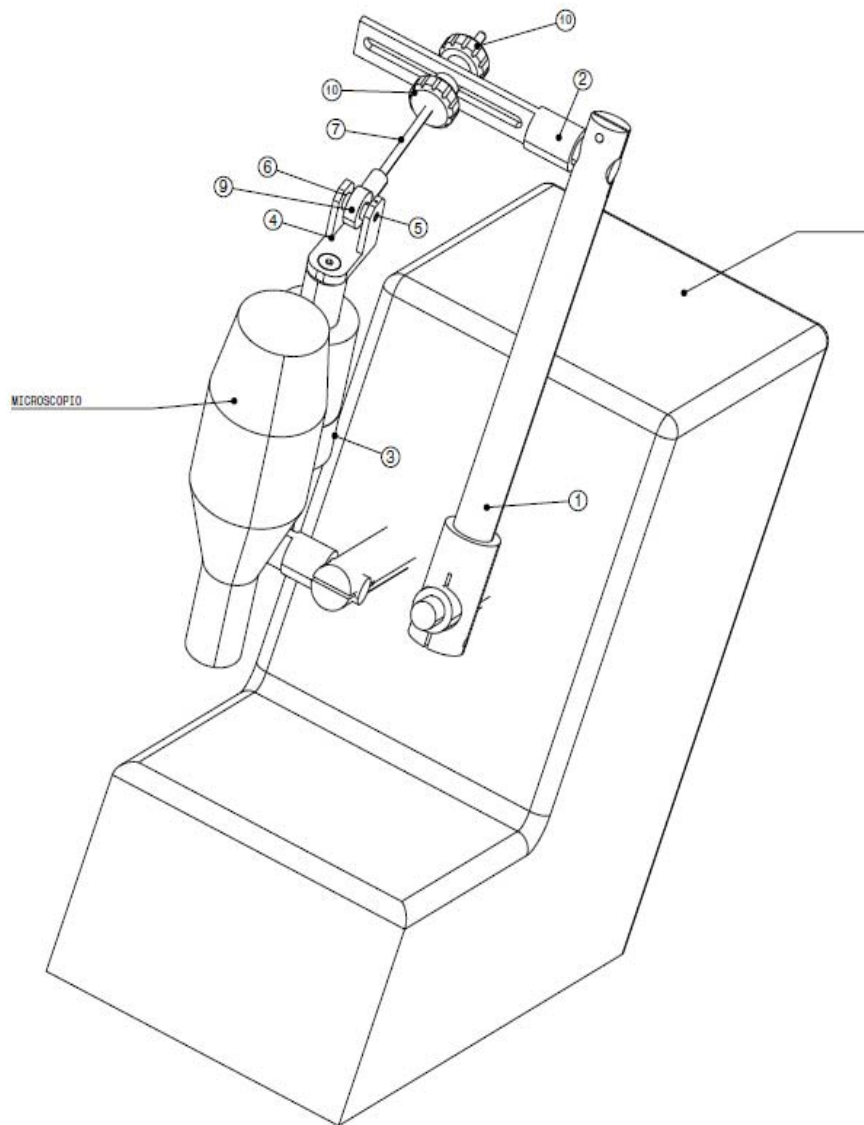


Ingrandimento Massimo : **154X**

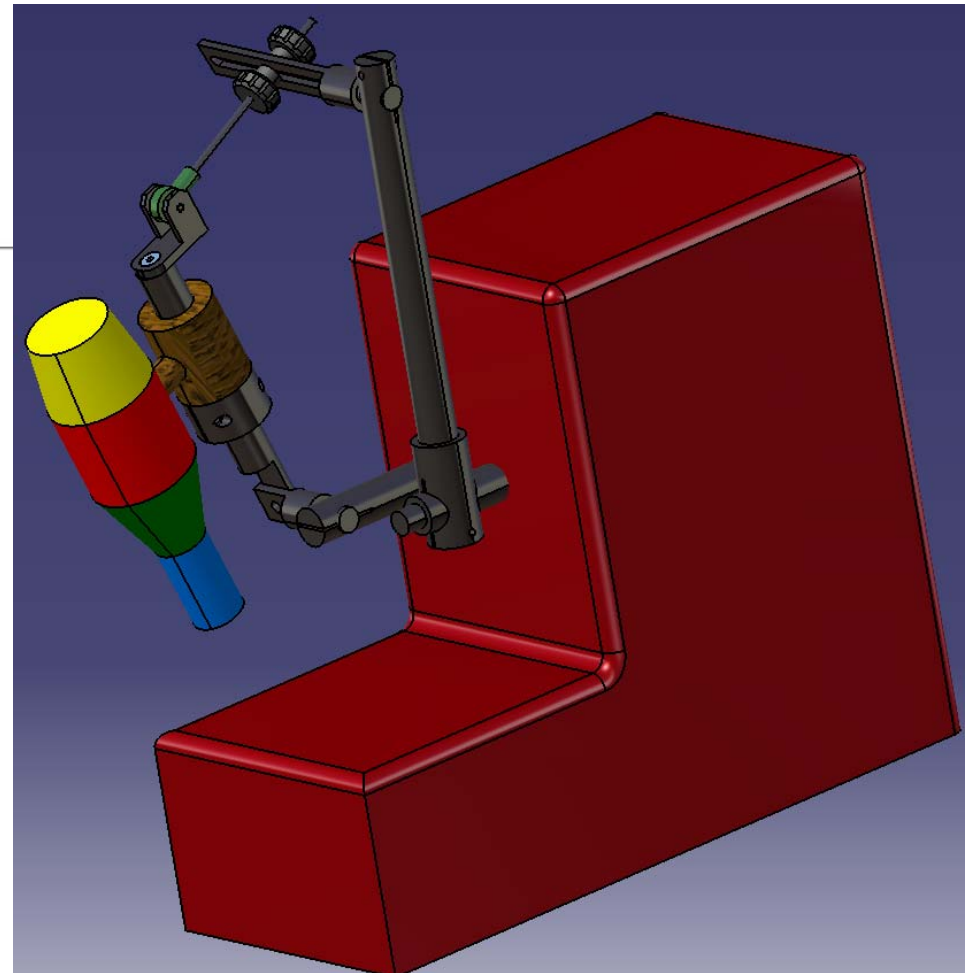


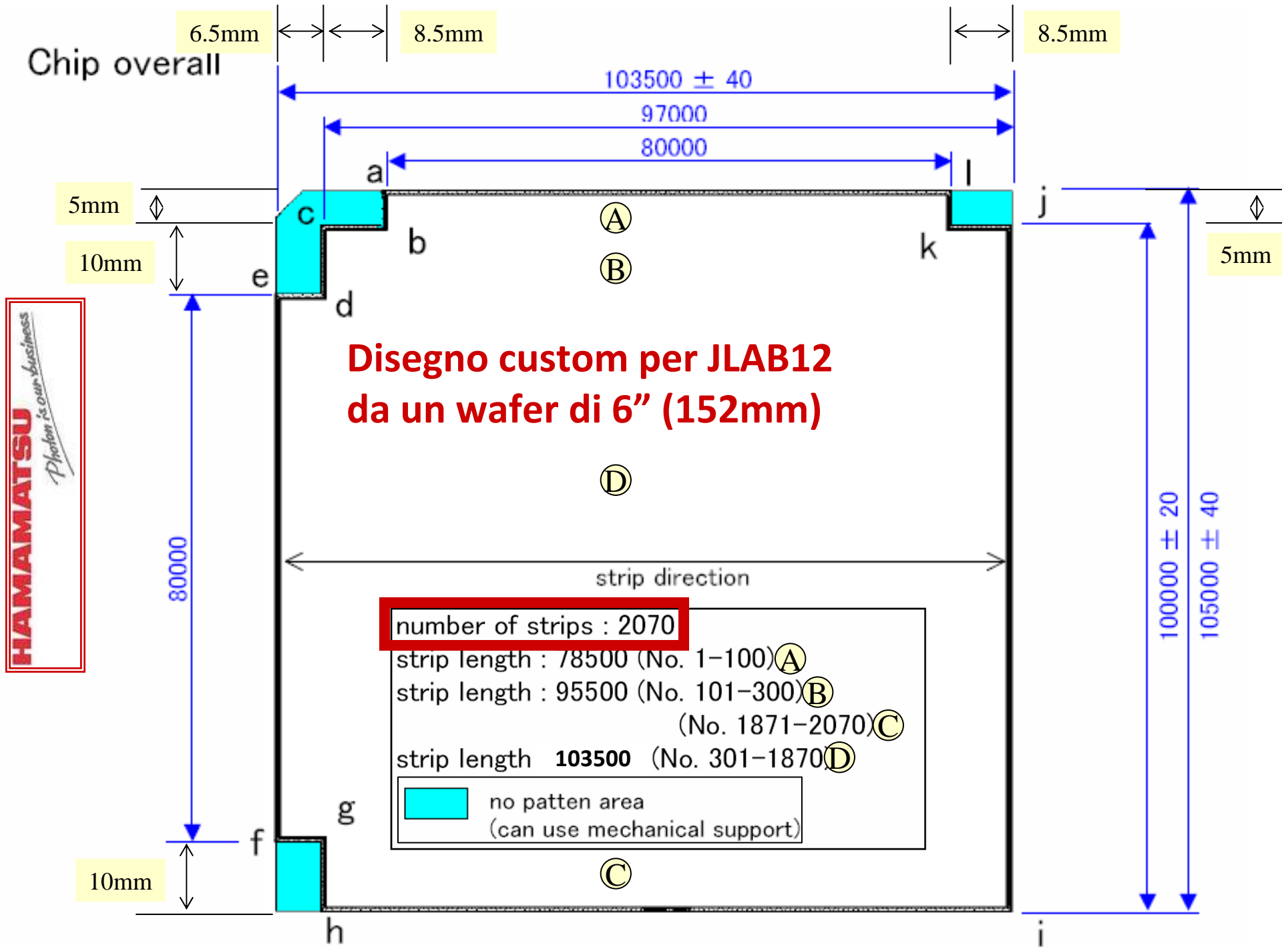


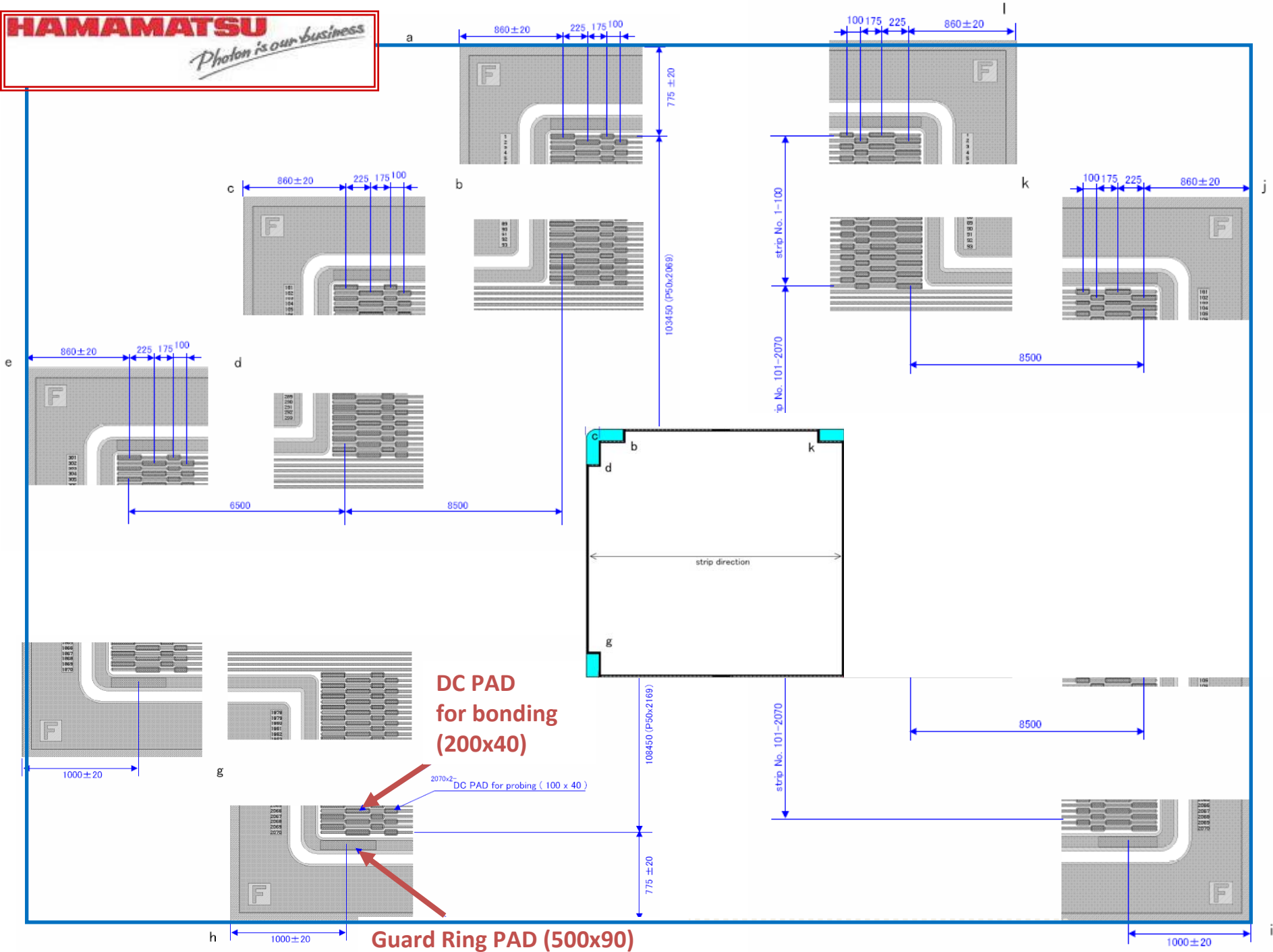
Supporto e Movimentazione fine per il Microscopio Leica sulla saldatrice

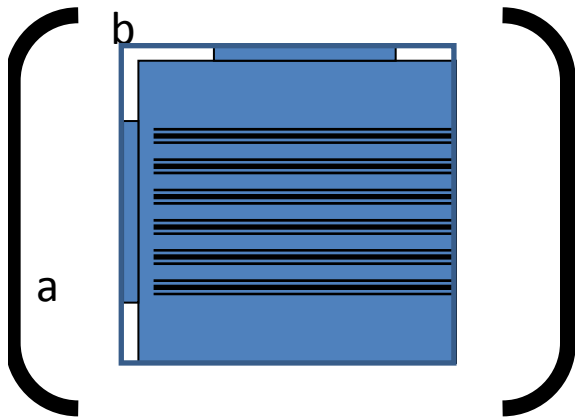


Vista isometrica
Scala: 4:0

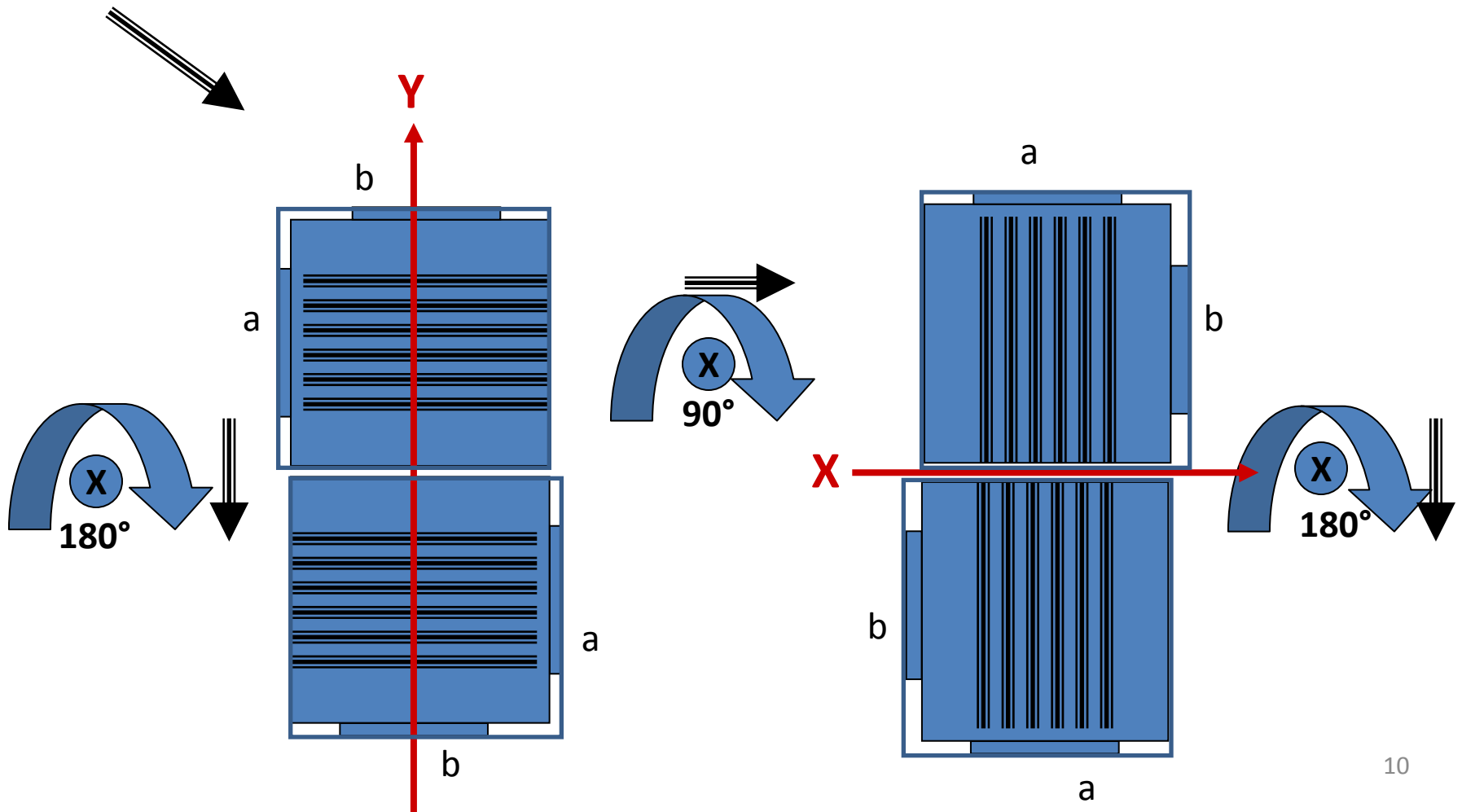








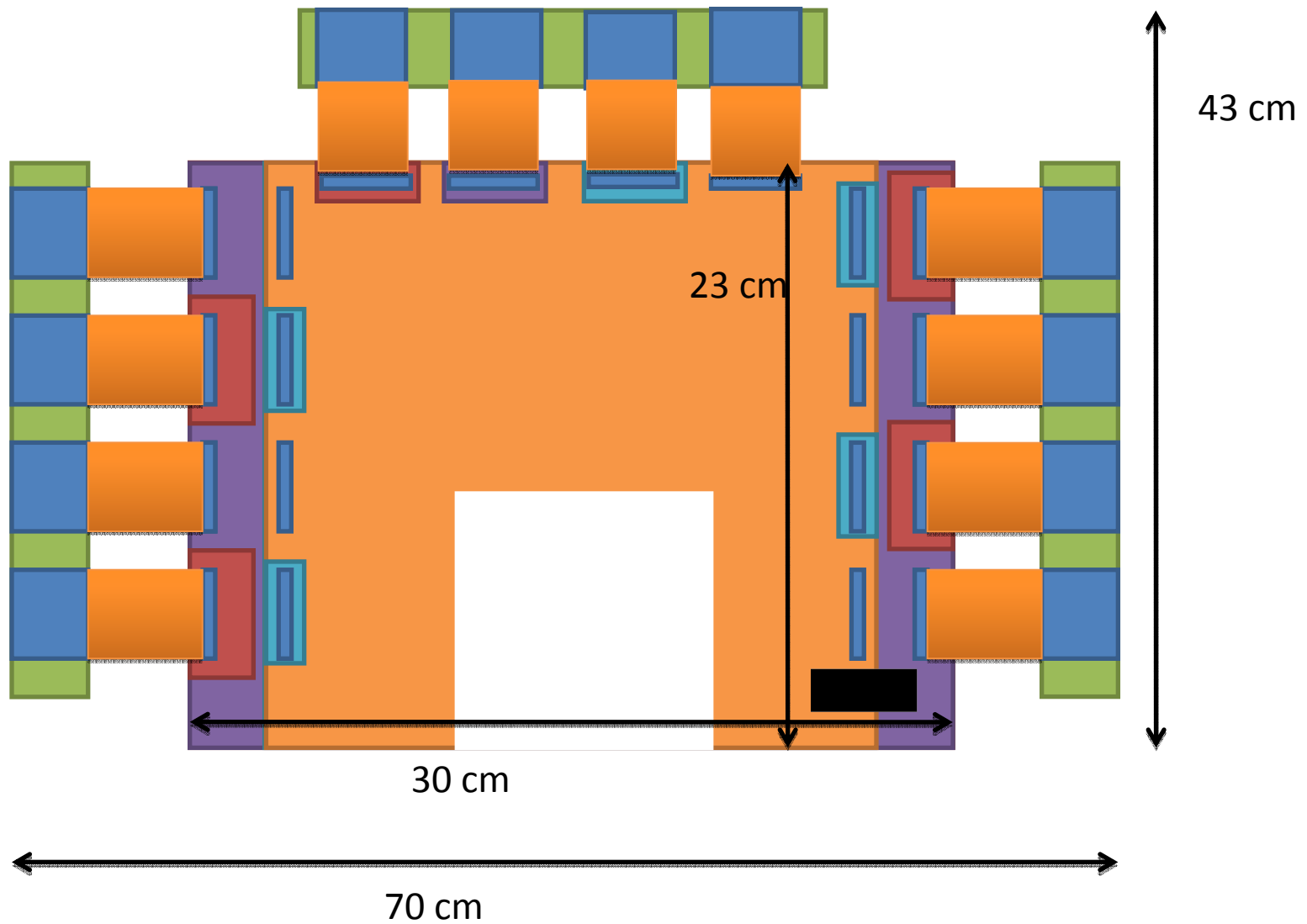
Dal rivelatore (Hamamatsu) ai Piani X e Y



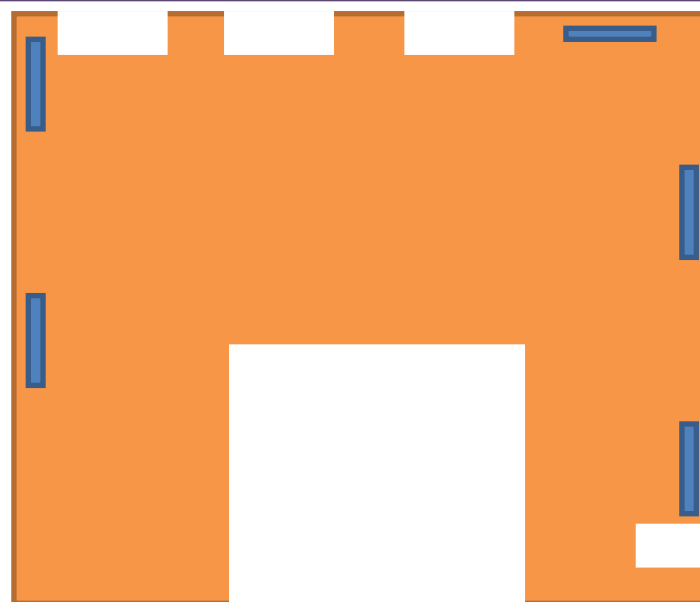
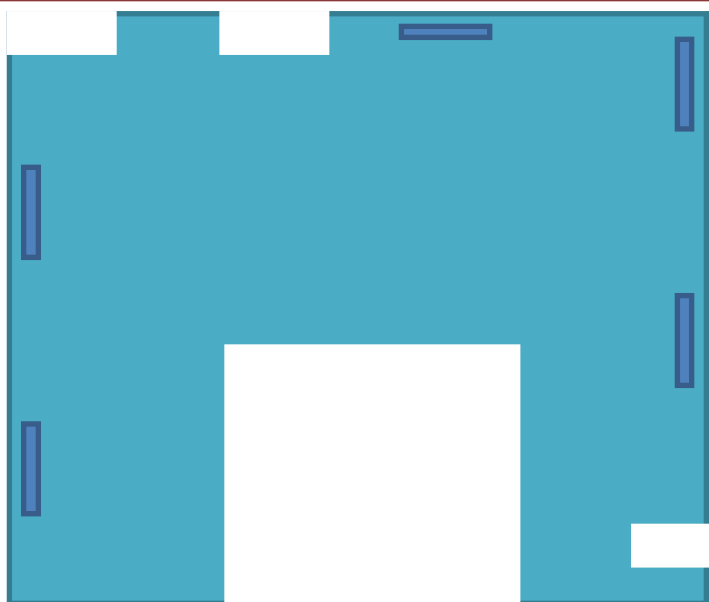
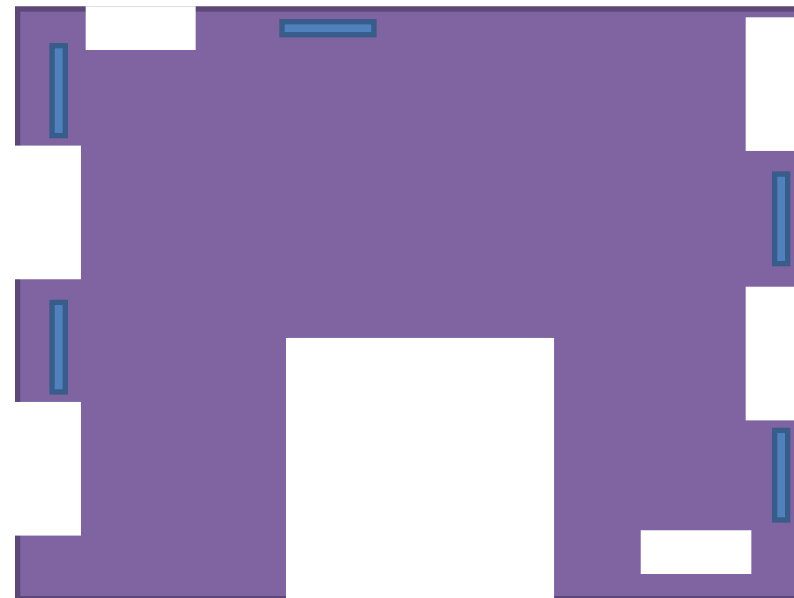
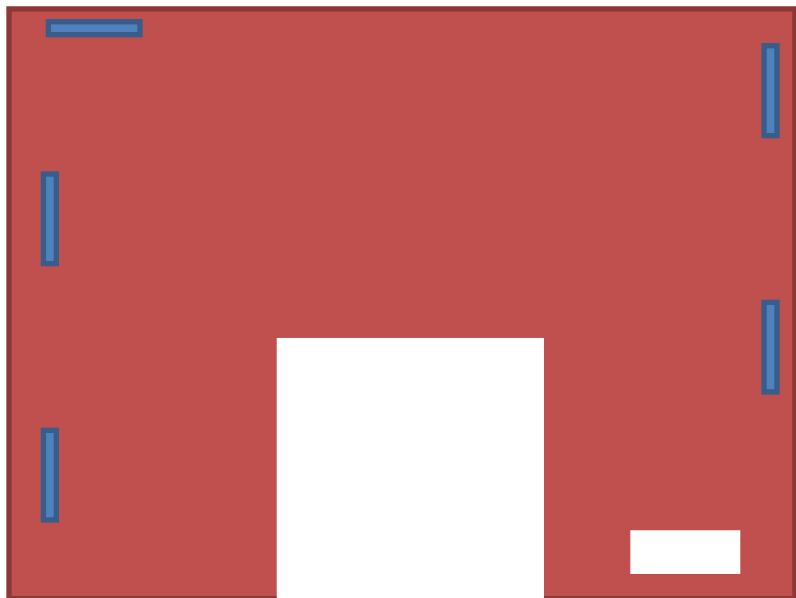
PCB Rigido per SiD:

- **Necessità di ottimizzare gli ingombri, e la lunghezza delle piste.**
- **Necessità di ottimizzare il piano di massa.**
- **Necessità di progettare due PCB rigidi distinti, di uguali dimensioni, per i piani X e Y.**
- **Necessità di prevedere una culla di alloggiamento del rivelatore al silicio (SiD) nel PCB rigido stesso.**
- **Necessità di poter essere realizzato con le attuali capacità tecnologiche ad un costo contenuto.**

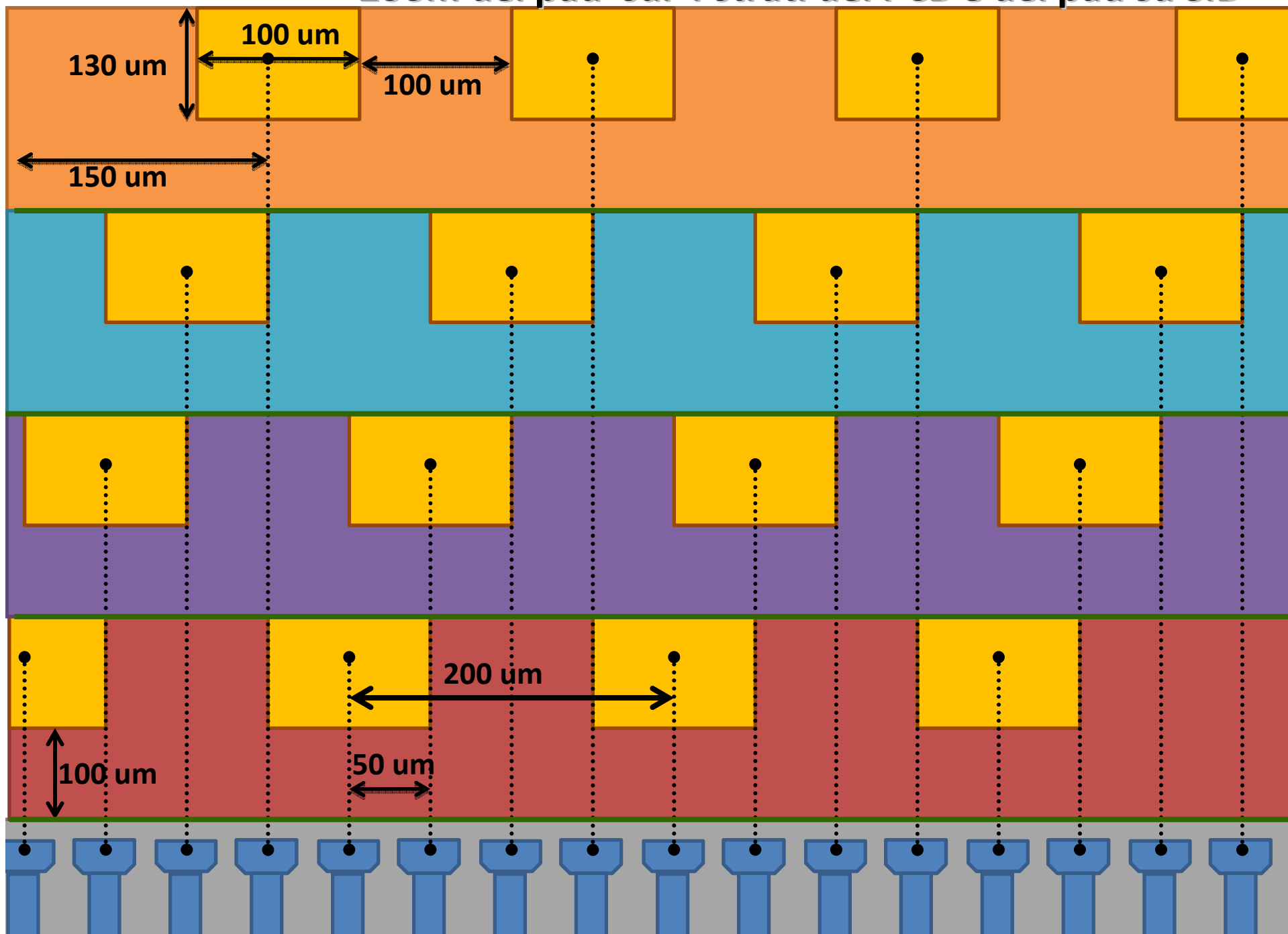
Vista Frontale del semi piano X



Divisione del PCB nei 4 Layer costituenti, 518 x 4 linee di segnale in totale

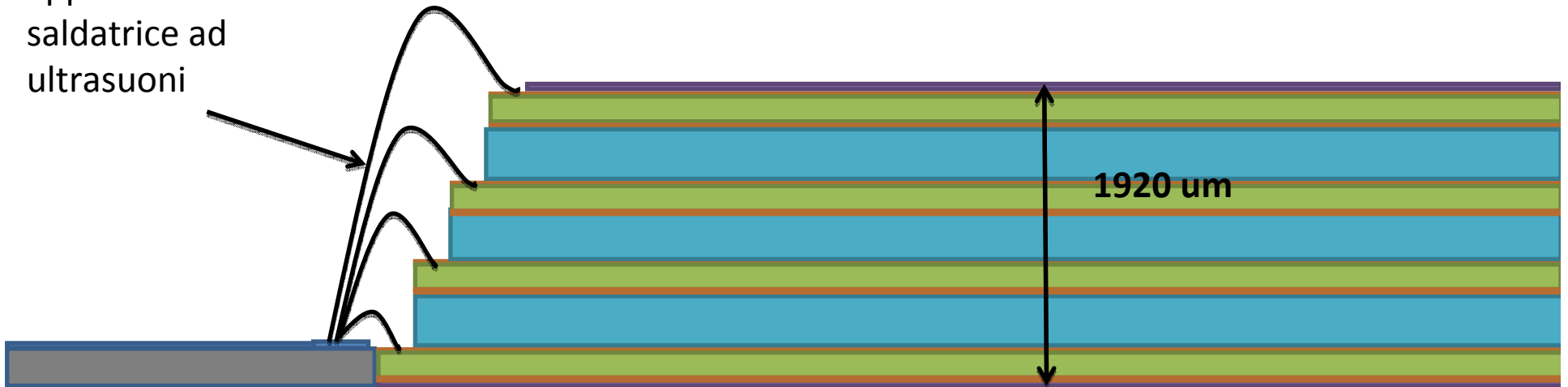


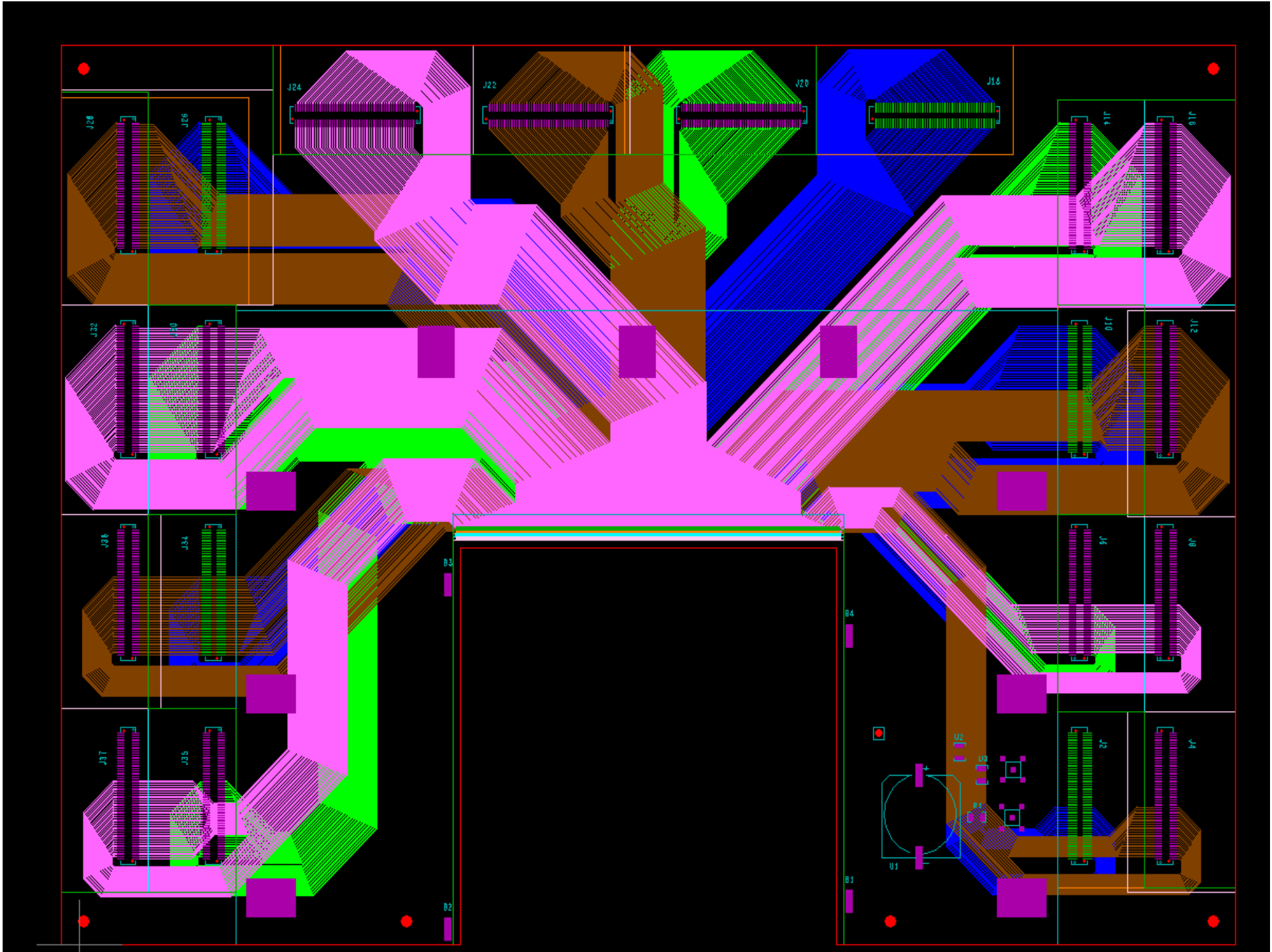
Zoom dei pad sui 4 strati del PCB e dei pad su SiD



Visione in sezione verticale dell'intero sistema SiD + PCB

Filo in alluminio
applicato con
saldatrice ad
ultrasuoni



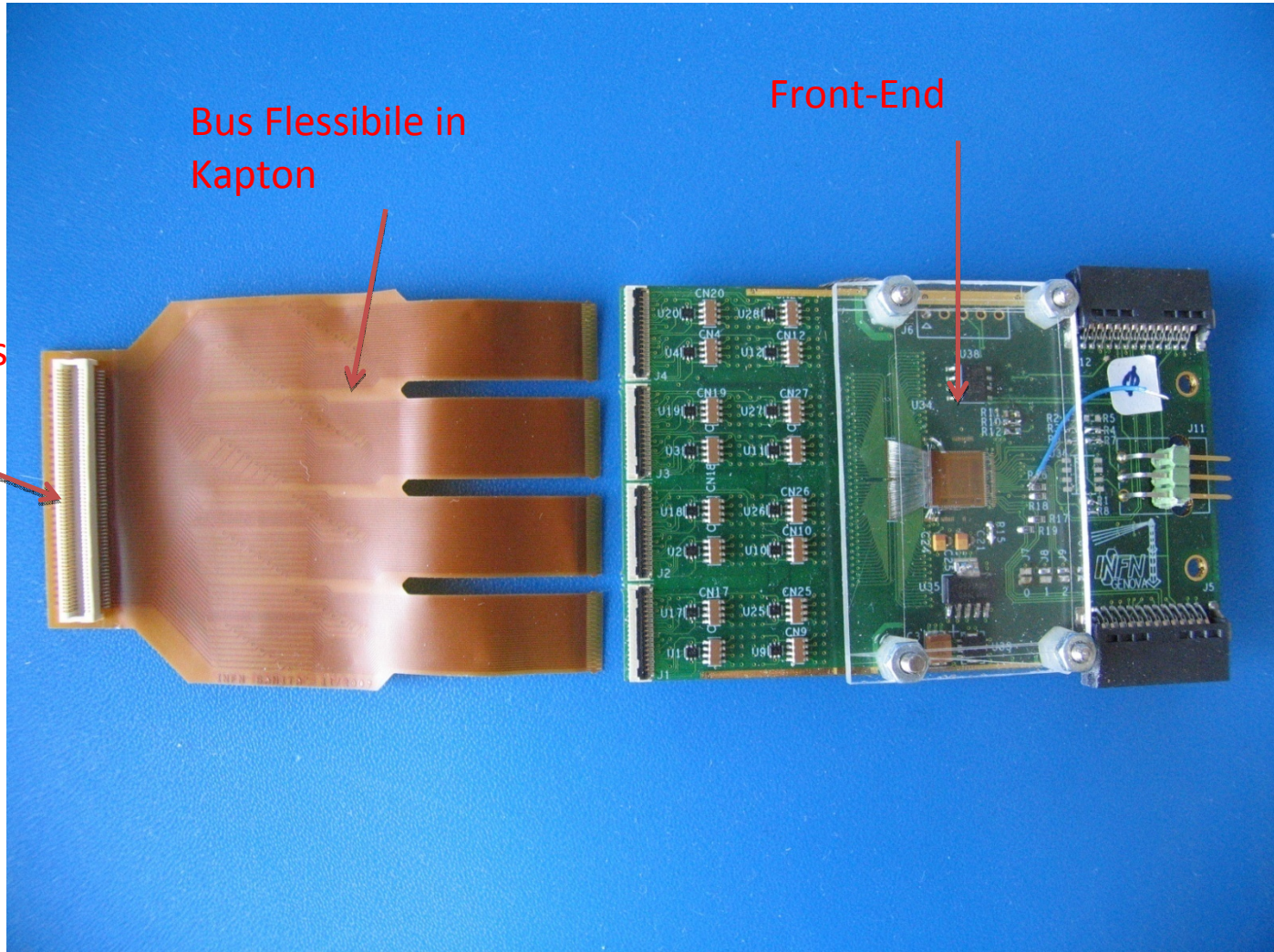


PCB + KAPTON + APV25

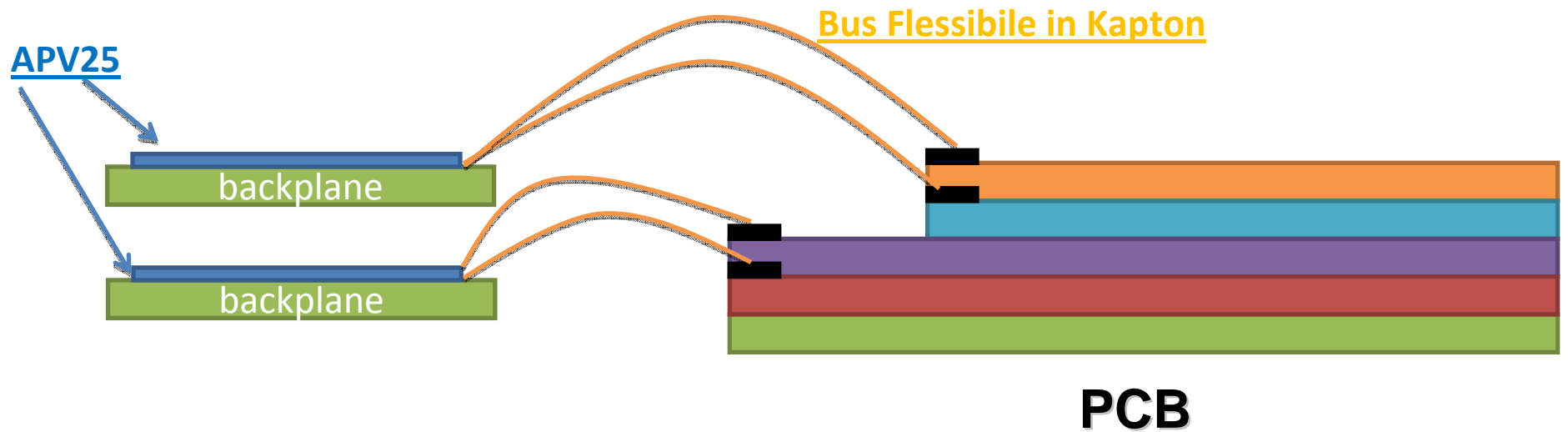
Connettore
Femmina bus
flessibile – bus
rigido

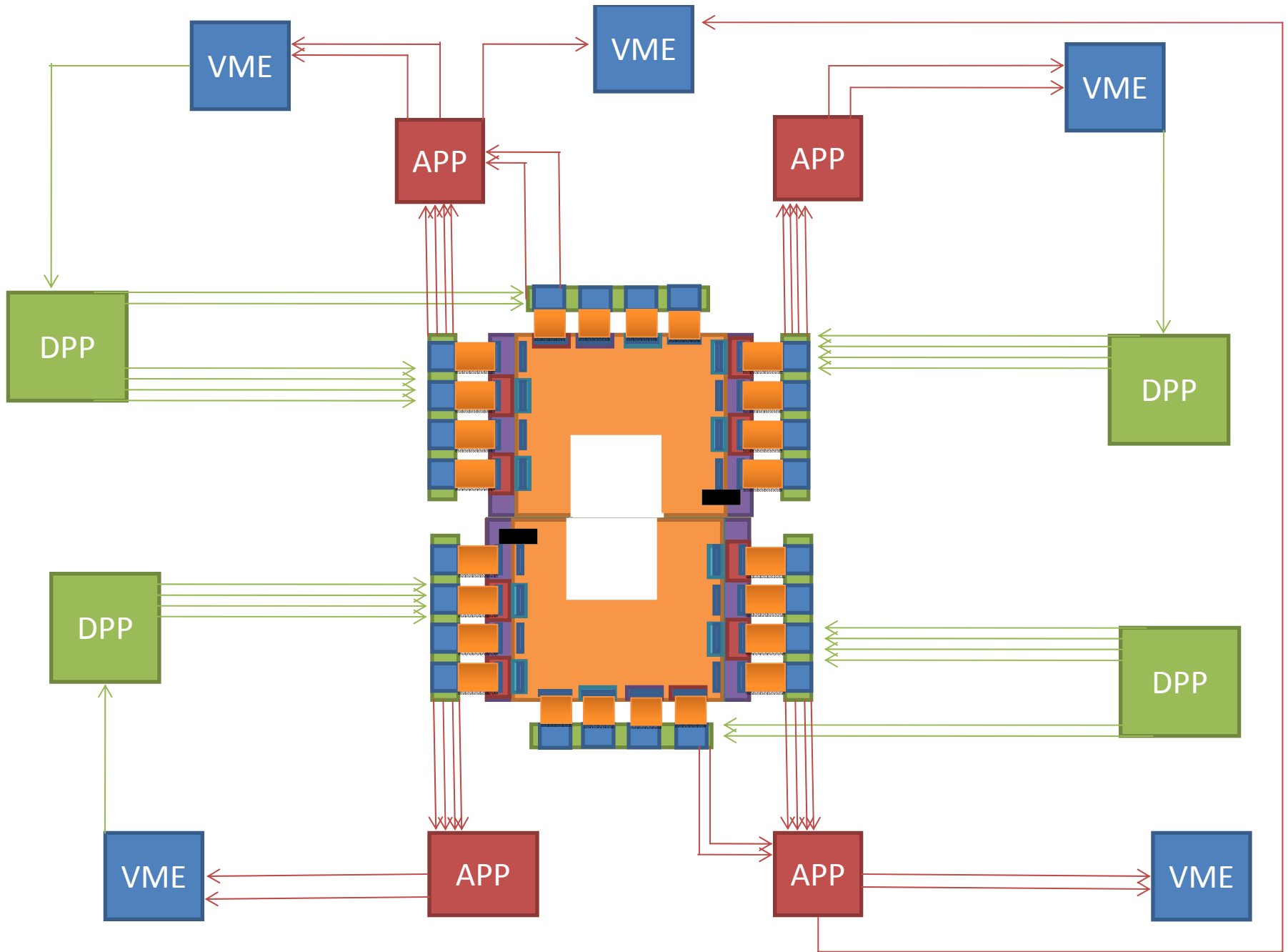
Bus Flessibile in
Kapton

Front-End

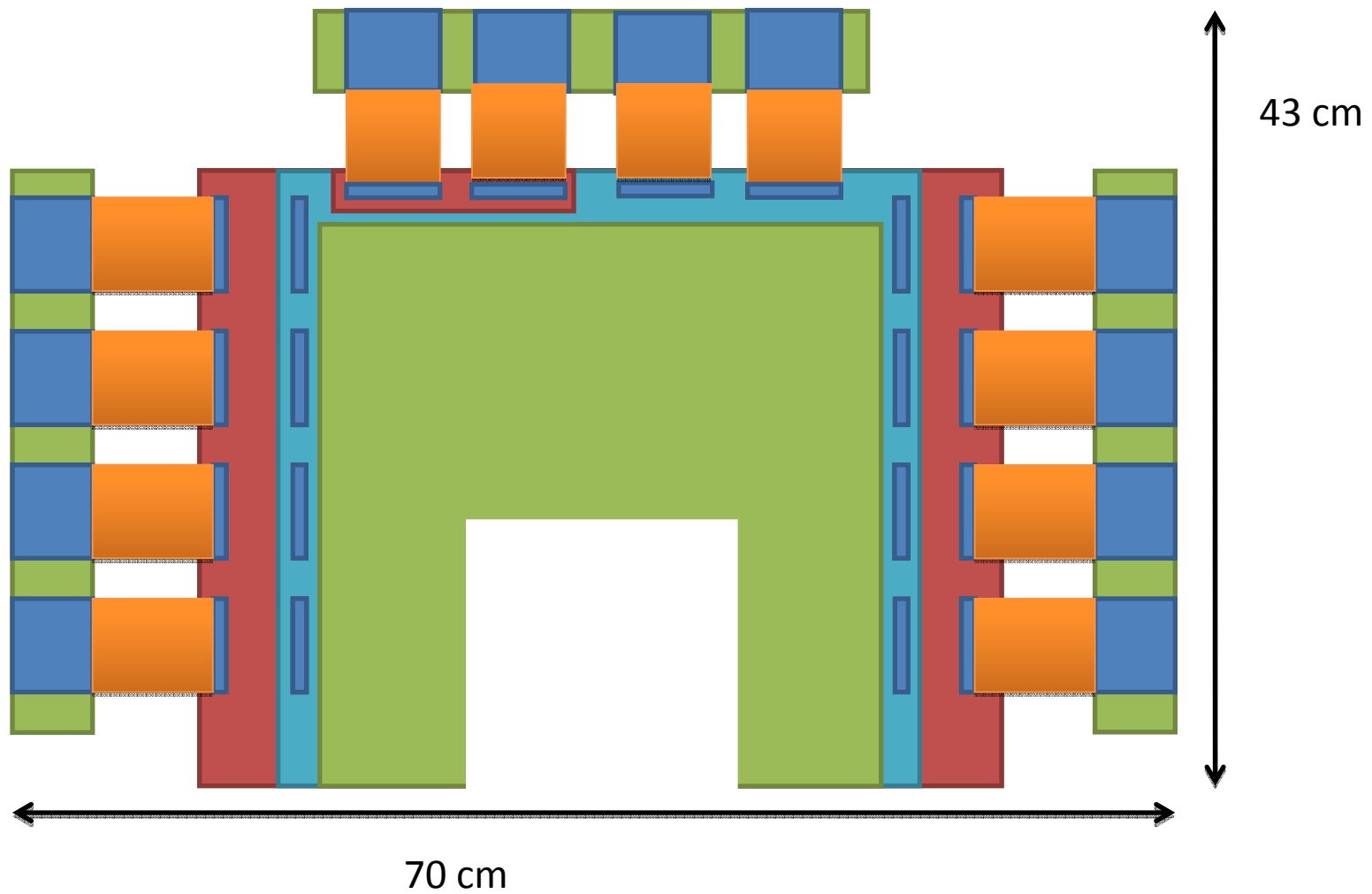


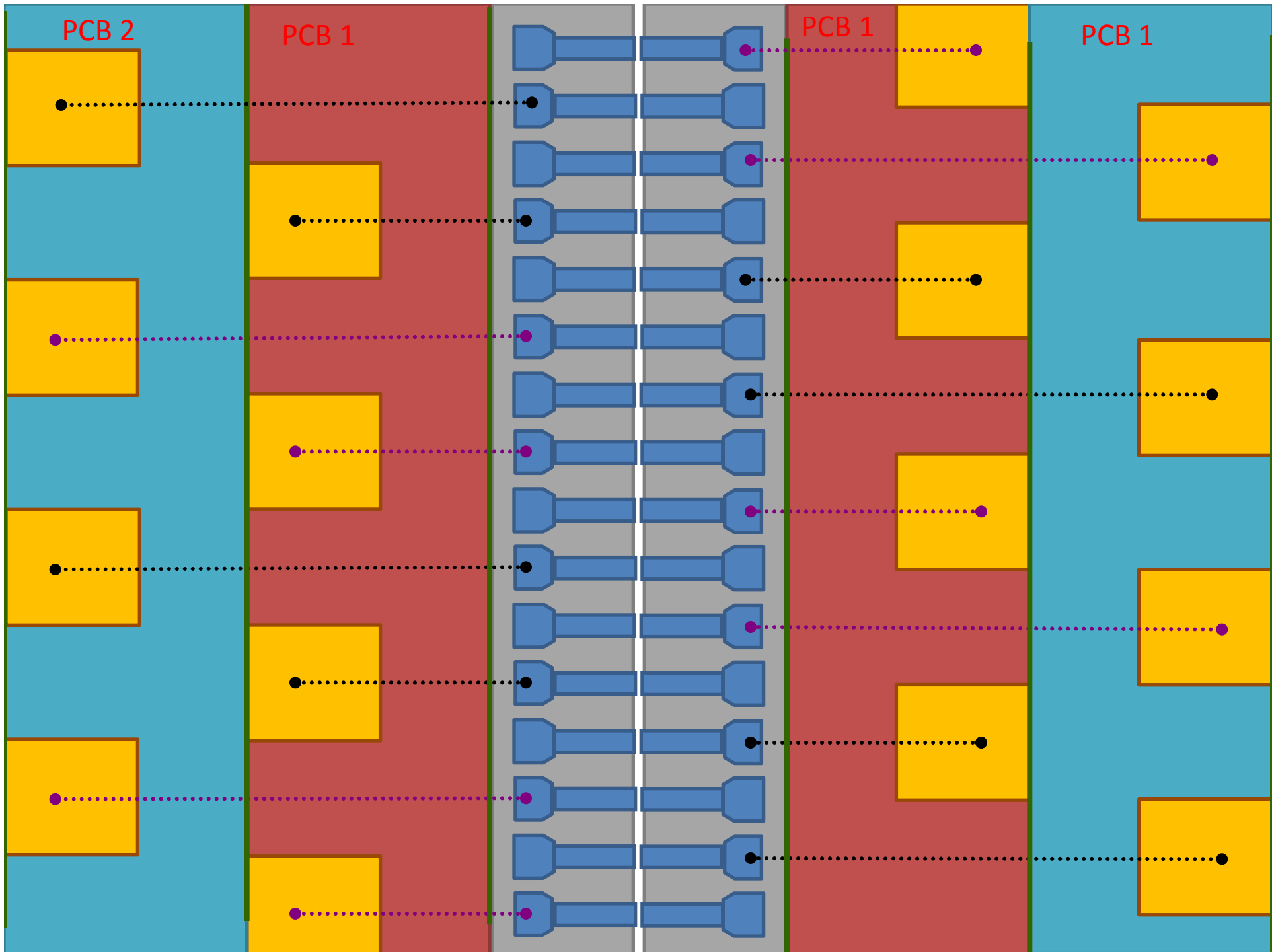
PCB + KAPTON + APV25 (terrazzati su Backplane a 2 livelli)



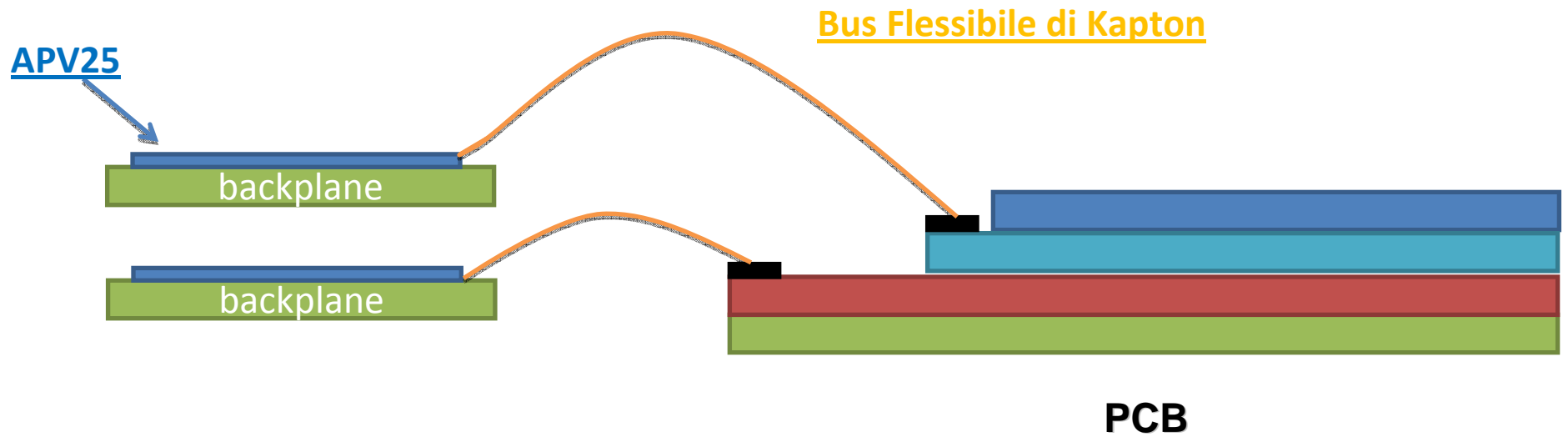


Vista Frontale del semi piano Y



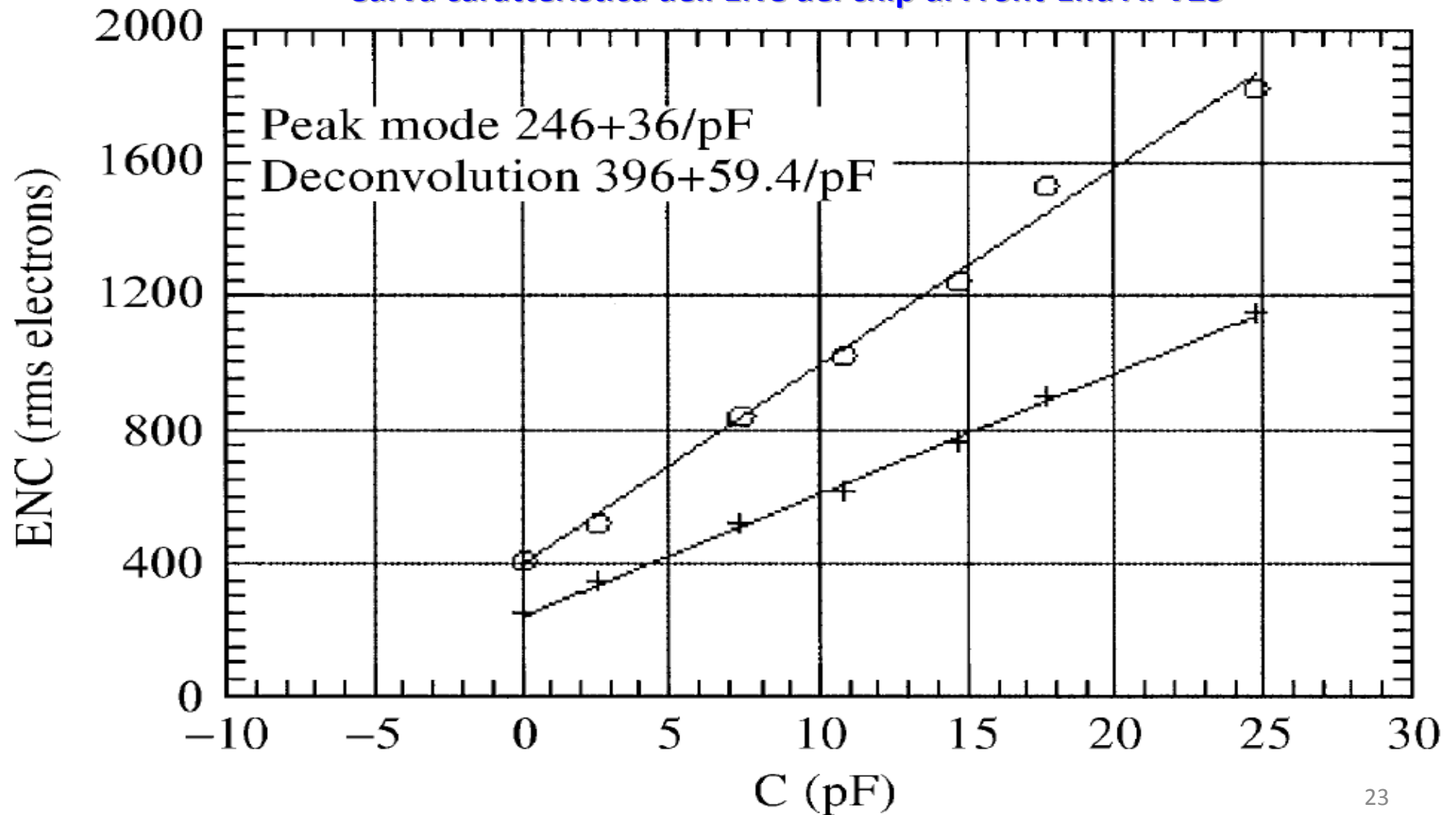


PCB + KAPTON + APV25 (terrazzati su Backplane a 2 livelli)



Studio del Piano di Massa: Importante per ottimizzare SNR

Curva caratteristica dell'ENC del chip di Front-End APV25



SNR al variare del numero dei piani di massa e della distanza dalle piste

N piani di Massa

nessun piano di Massa

5 piani di Massa

2 piani di Massa Layer 0 et Layer 3

1 piano di Massa BOTTOM 200 um Layer 0

1 piano di Massa BOTTOM 700 um Layer 0

1 piano di Massa BOTTOM 1200 um Layer 0

1 piano di Massa BOTTOM 200 um Layer 0, piano di massa sagomato a 20 cm

1 piano di Massa BOTTOM 700 um Layer 0, piano di massa sagomato a 20 cm

1 piano di Massa BOTTOM 1200 um Layer 0, piano di massa sagomato a 20 cm

Non e'
realistico!

SNR L = 10 cm

SNR L = 30 cm

21.78

15.65

11.31

4.35

13.33

5.59

13.13

5.42

16.19

8.12

17.43

9.55

14.87

7.38

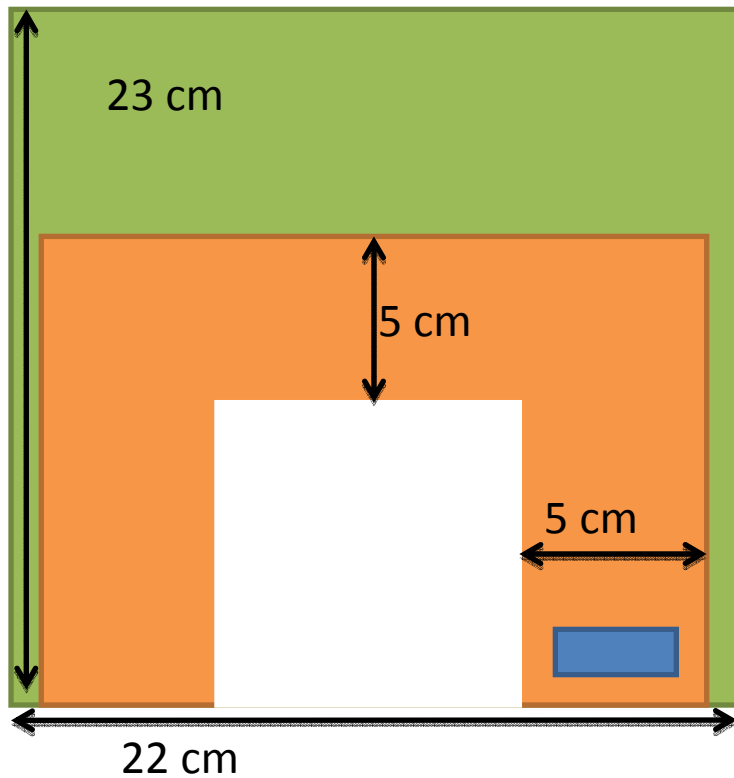
16.19

10.21

17.43

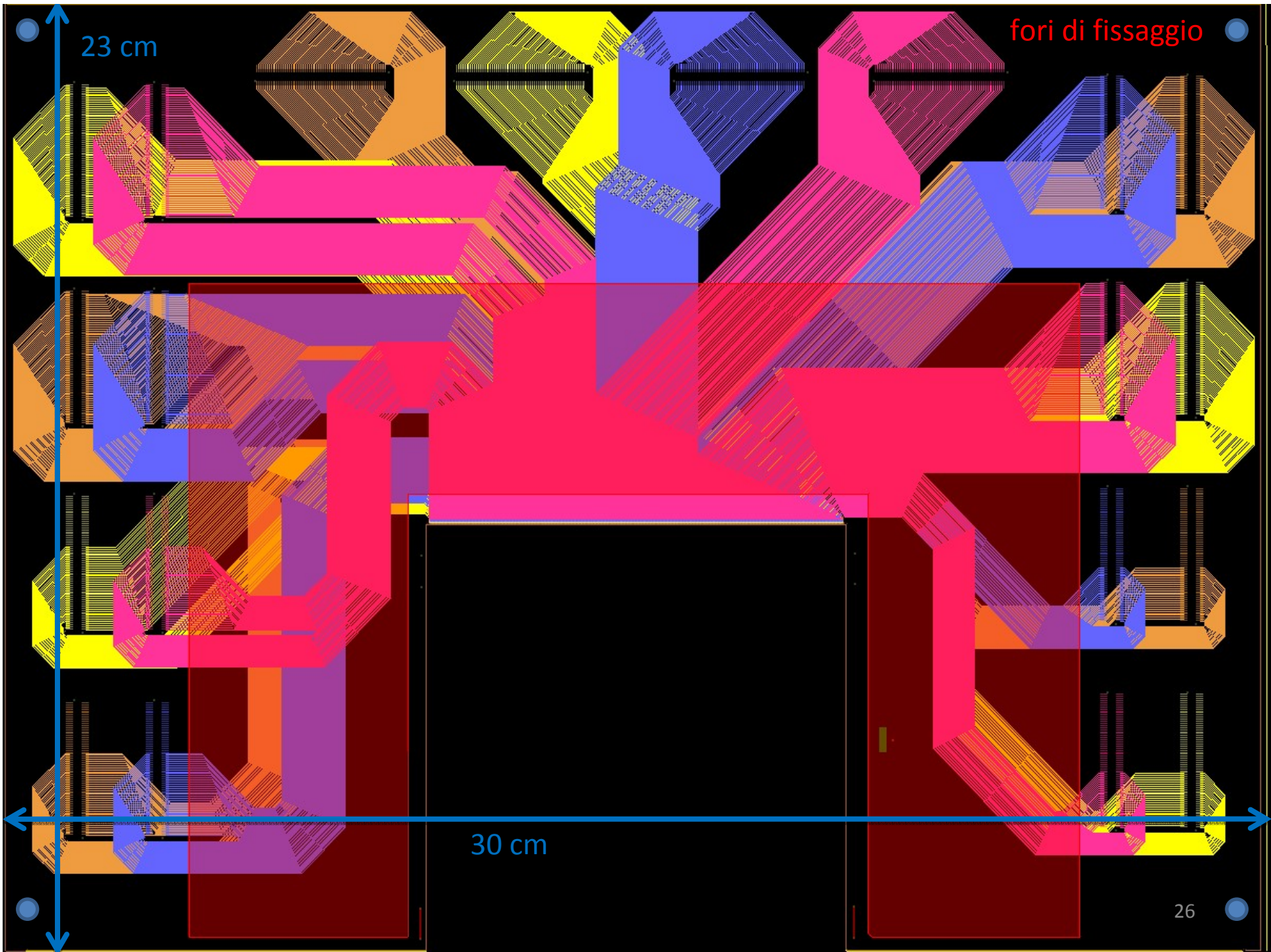
11.24

Soluzione Adottata :



PCB 5 (Top) : con piano di massa ridotto e circuito di Pulsing

→ SNR = 16 ~ 20



Simulazione Strip di maggiore lunghezza in PCB4 : L = 20.1 cm.
Distanza minore dal piano di massa (PCB 4) 630 um.
5.6 cm di percorrenza sotto il piano di massa.

Embedded Microstrip Impedance Calculator:

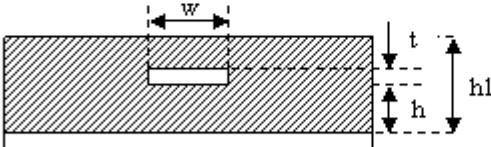
$$Z_0 = \frac{60}{\sqrt{\epsilon_{rp}}} \ln \left(\frac{5.98h}{(0.8w+t)} \right) \quad T_{pd} = 0.278 \sqrt{\epsilon_{rp}}$$

$$\epsilon_{rp} = \epsilon_{rp} \left(1 - \exp \left(-1.55 \frac{h_1}{h} \right) \right)$$

**Valori per tratto
sotto il piano di
massa**

Note: valid for (h1/h) greater than 1.2

Dimensional units: mm mils

w (trace width) =	0.1
t (trace thickness) =	0.02
h (trace dielectric thickness) =	0.63
h1 (overall dielectric thickness) =	3.78
er (relative dielectric constant) =	4.5
	Calculate
Zo (Impedance, Ohms) =	102.647
Propagation Delay, Tpd (ps/cm) =	58.970
Inductance, L (nH/cm) =	6.053
Capacitance, C (pF/cm) =	0.57449

Note: 1oz = 1.4mils = 0.03556mm

Embedded Microstrip Impedance Calculator:

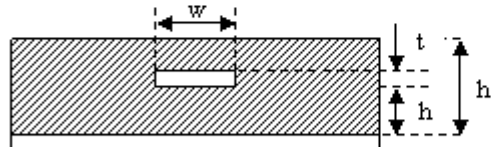
$$Z_0 = \frac{60}{\sqrt{\epsilon_{rp}}} \ln \left(\frac{5.98h}{(0.8w+t)} \right) \quad T_{pd} = 0.278 \sqrt{\epsilon_{rp}}$$

$$\epsilon_{rp} = \epsilon_{rp} \left(1 - \exp \left(-1.55 \frac{h_1}{h} \right) \right)$$

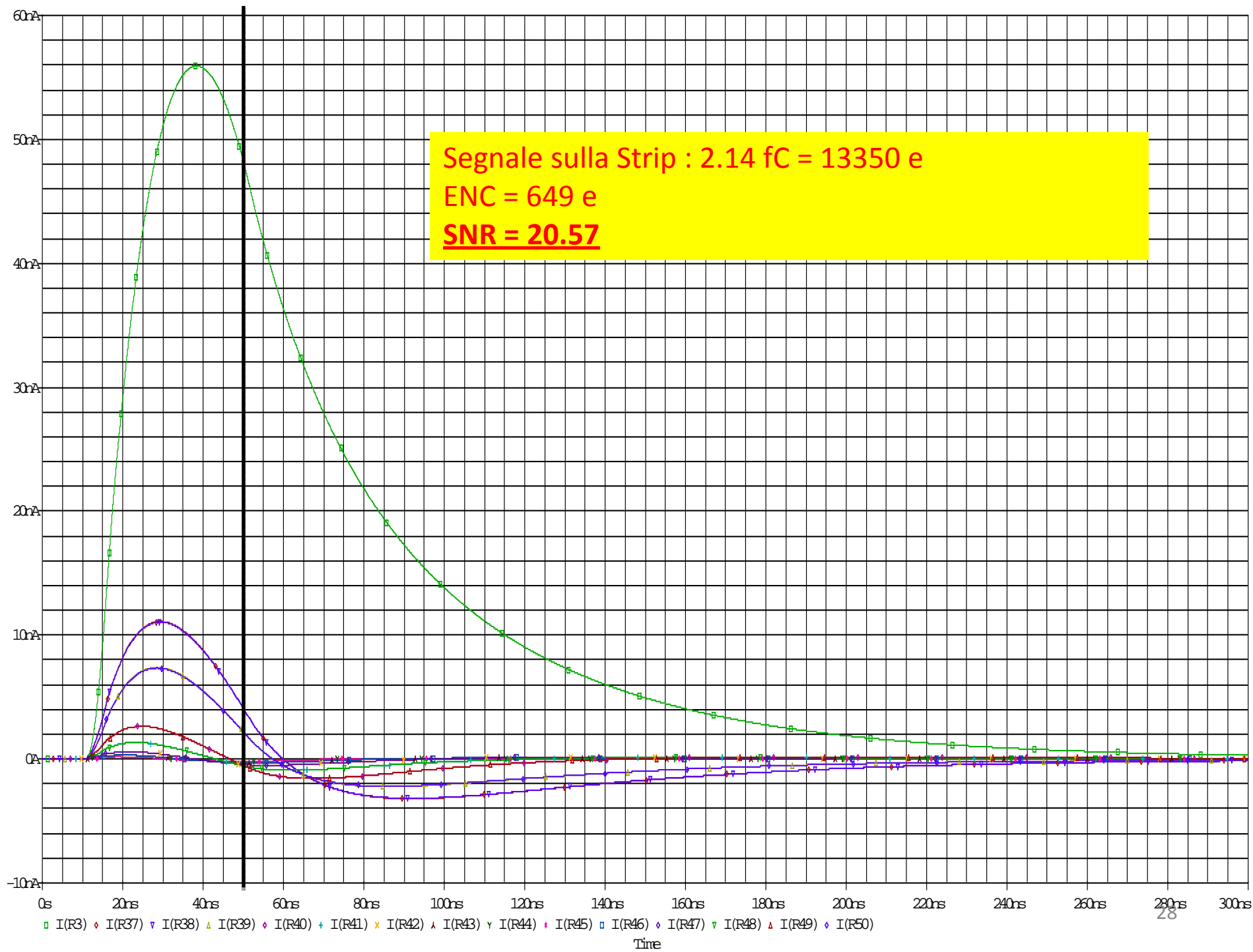
**Valori per tratto
senza il piano di
massa**

Note: valid for (h1/h) greater than 1.2

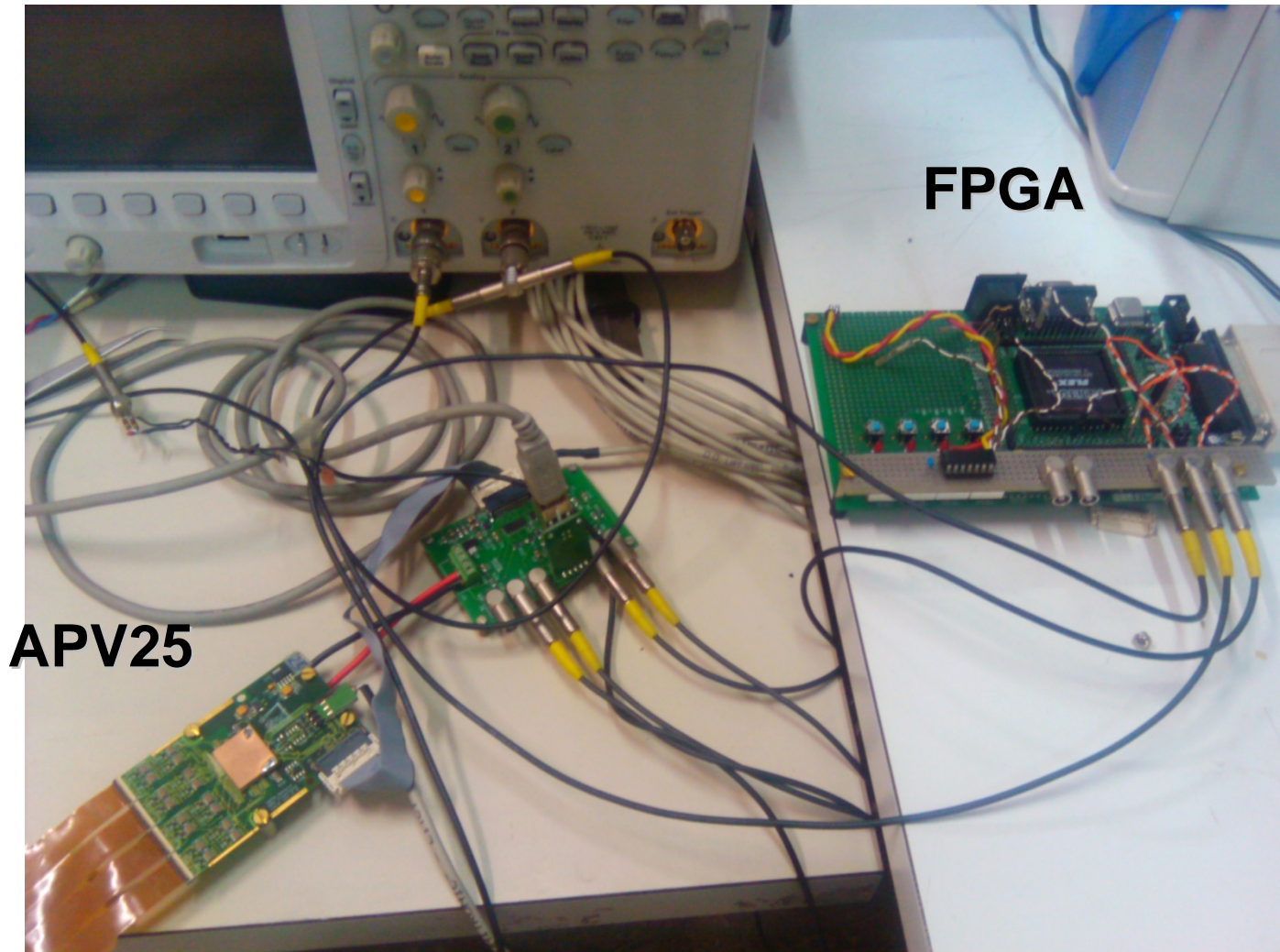
Dimensional units: mm mils

w (trace width) =	0.1
t (trace thickness) =	0.02
h (trace dielectric thickness) =	1000000
h1 (overall dielectric thickness) =	1000030
er (relative dielectric constant) =	4.5
	Calculate
Zo (Impedance, Ohms) =	570.635
Propagation Delay, Tpd (ps/cm) =	52.342
Inductance, L (nH/cm) =	29.868
Capacitance, C (pF/cm) =	0.09173

Note: 1oz = 1.4mils = 0.03556mm



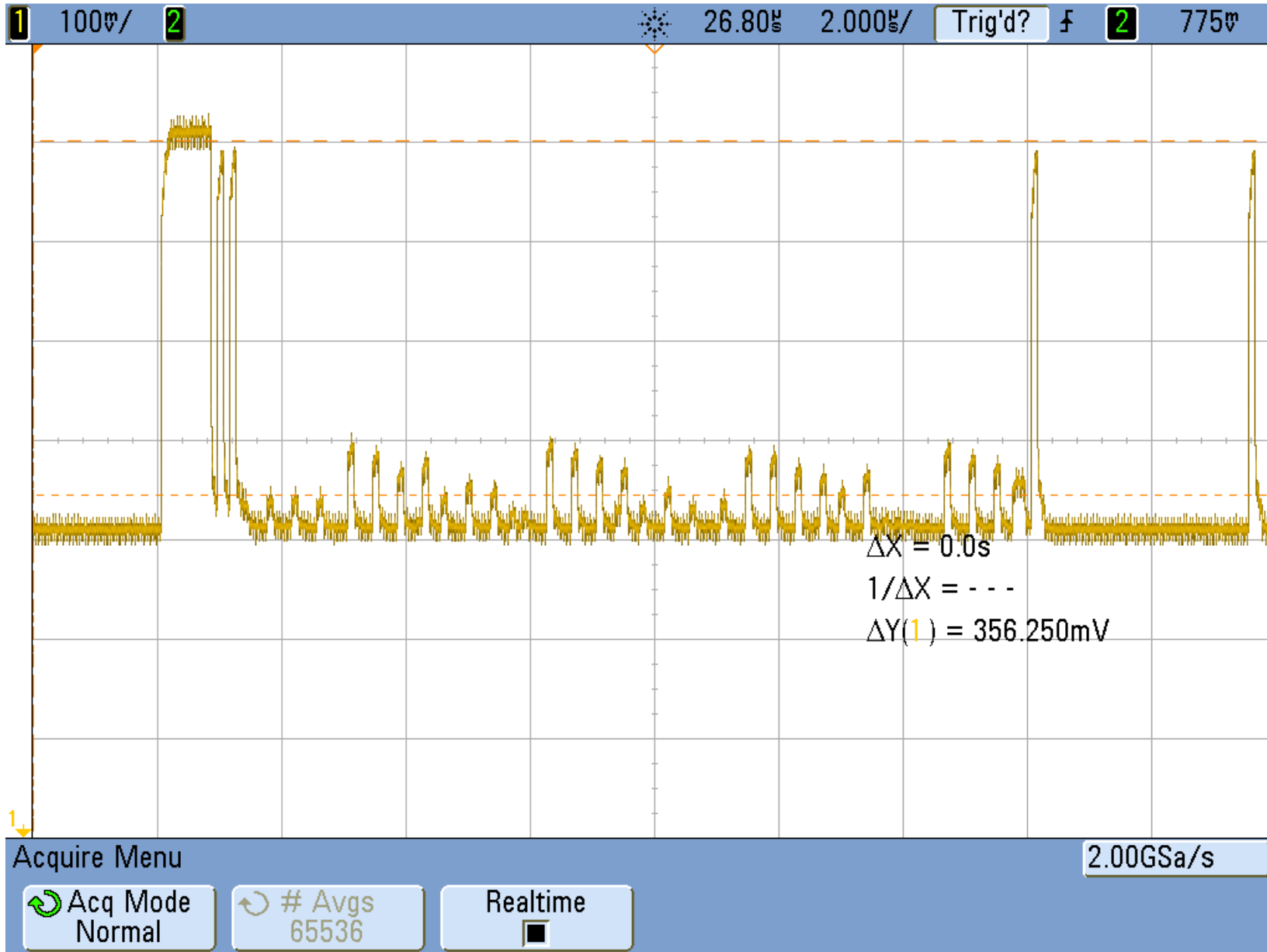
APV25 + FPGA



Test dei canali 0-31

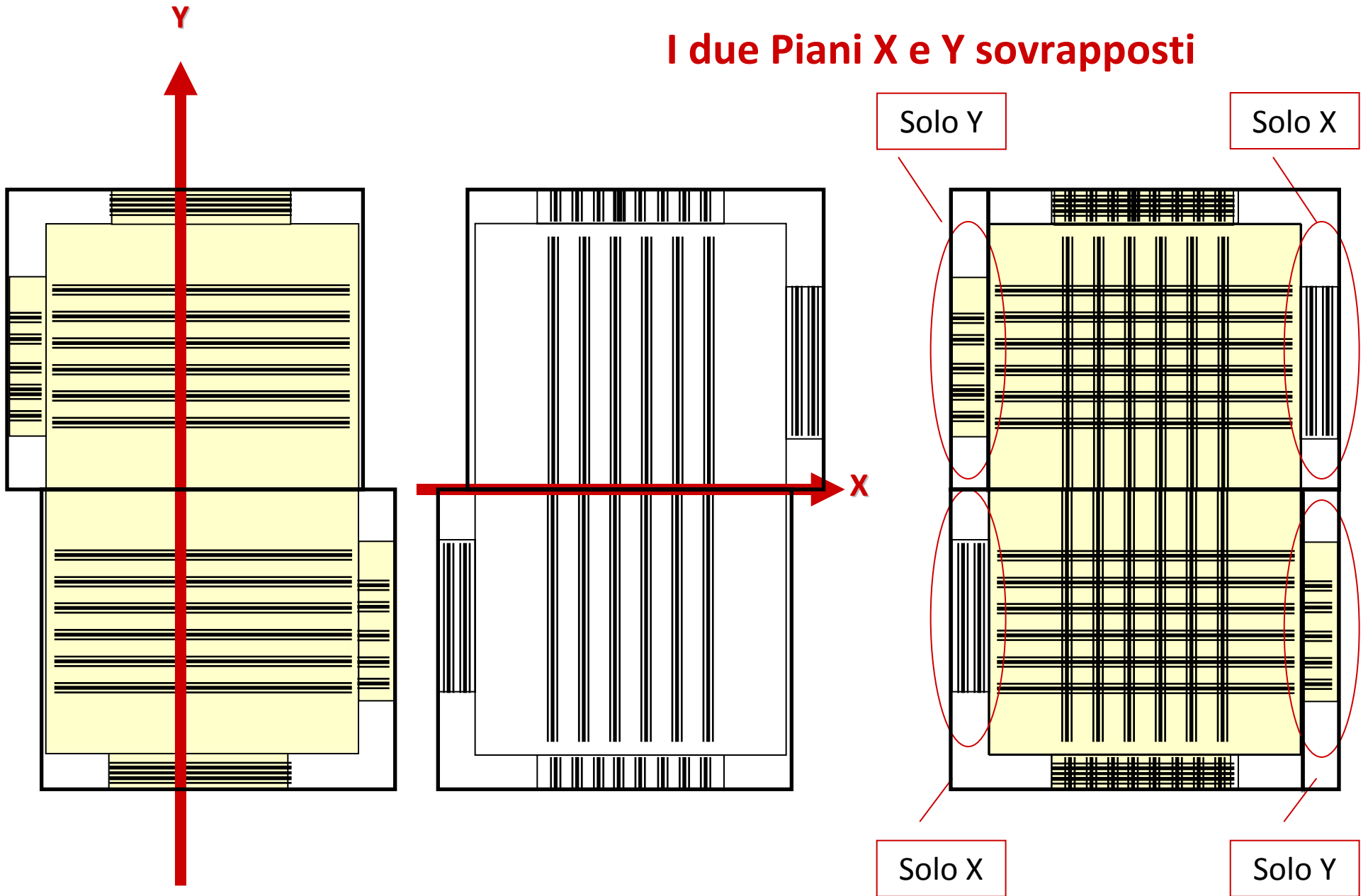
Agilent Technologies

TUE MAY 31 22:27:19 2011

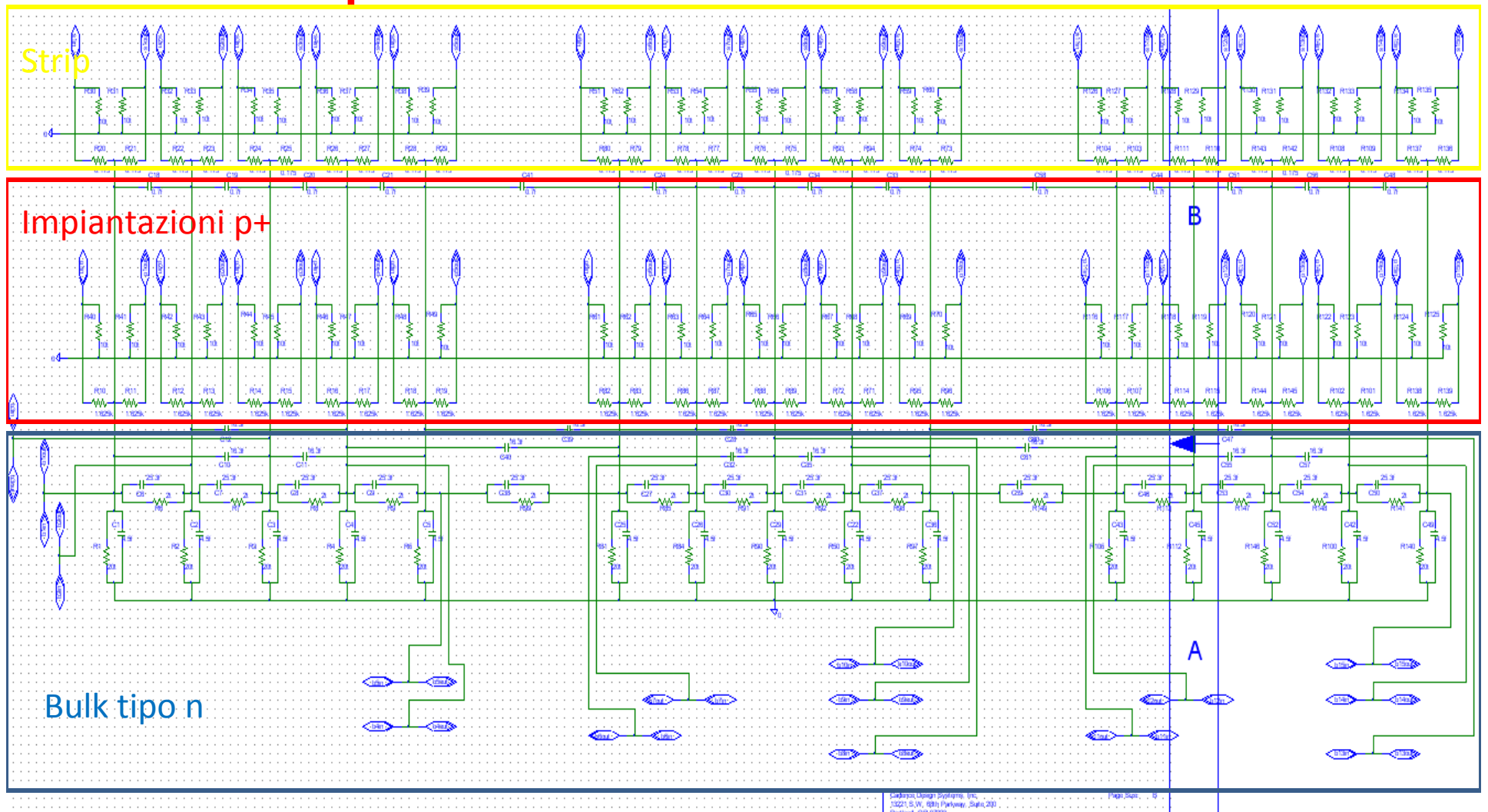


RISERVA

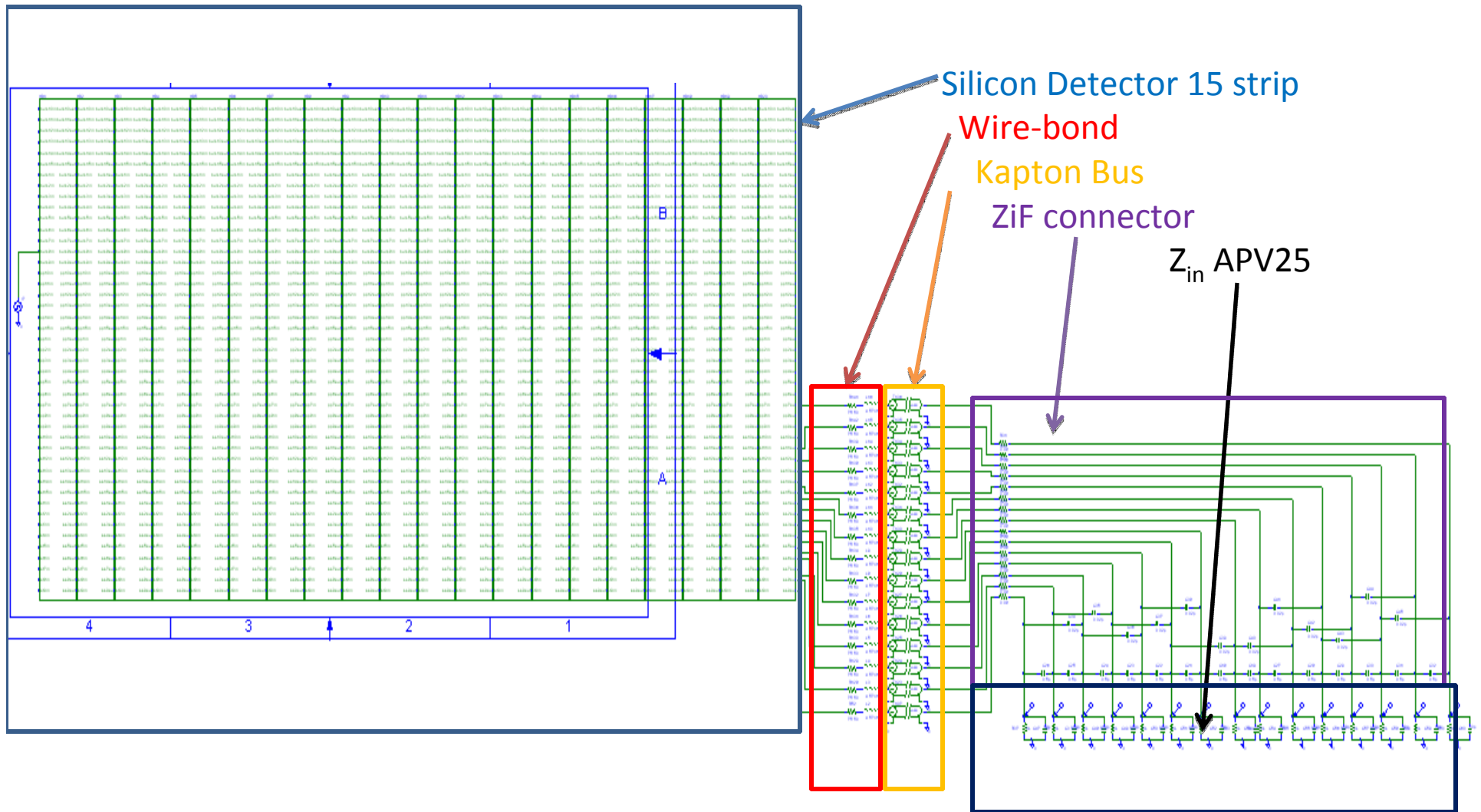
I due Piani X e Y sovrapposti



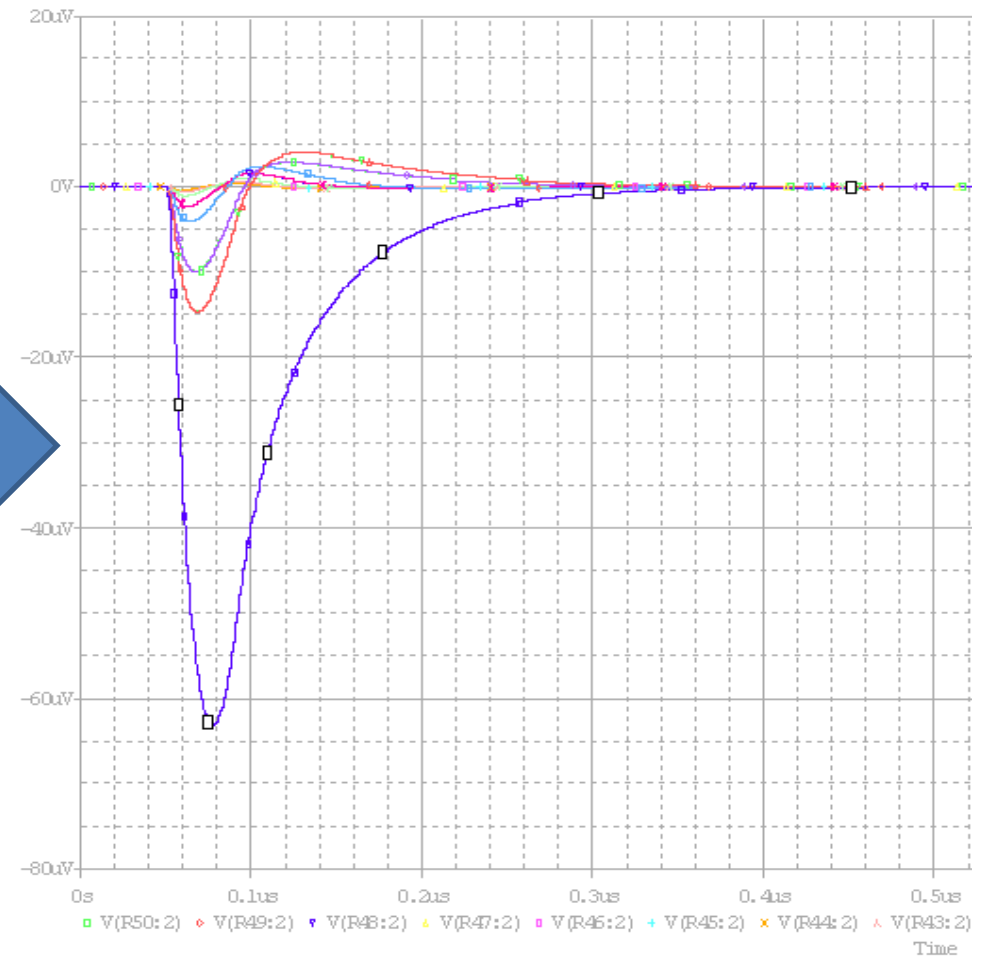
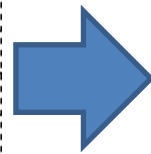
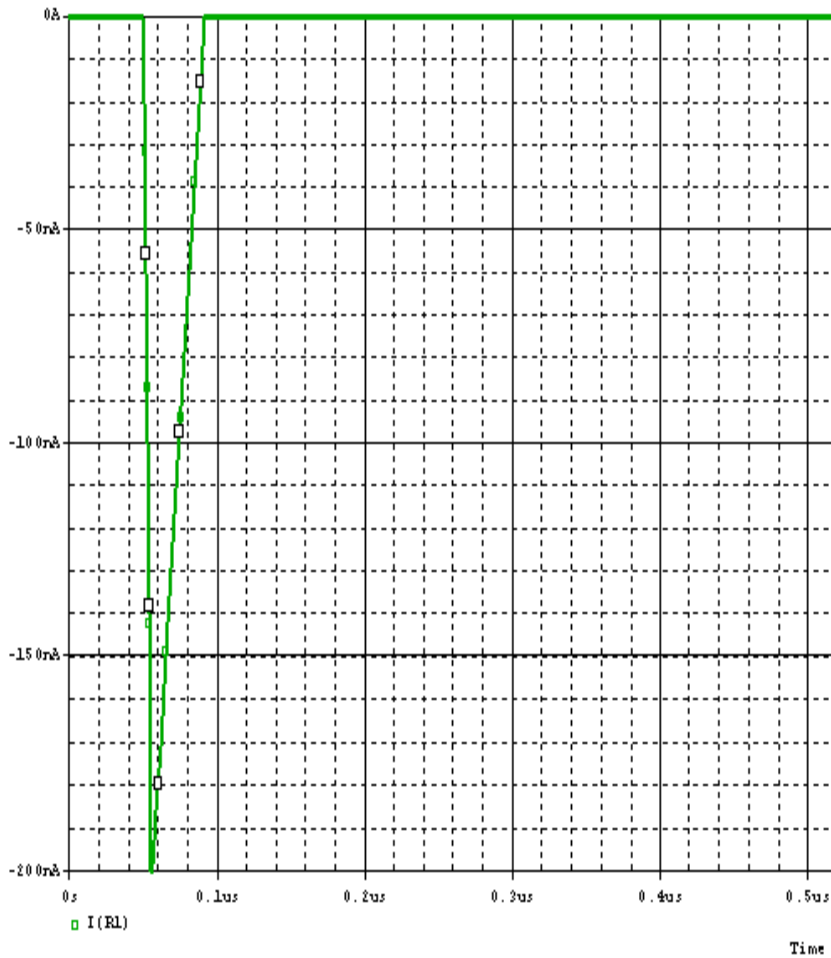
Microcella del Rivelatore con parametri HAMAMATSU



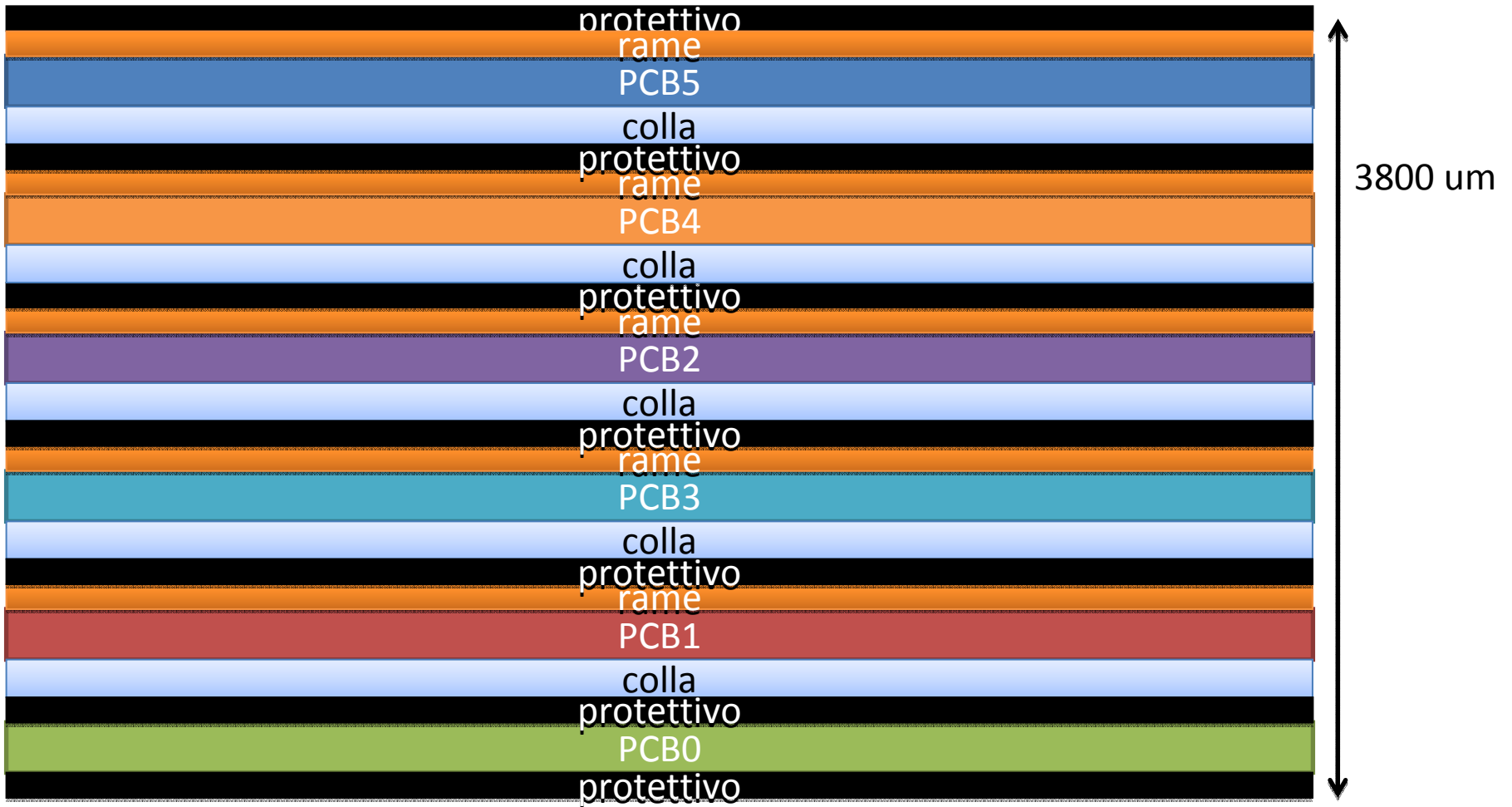
Schema Circuitale completo



Risposta del rivelatore di 10 cm ad una MIP all'ingresso dell'APV25

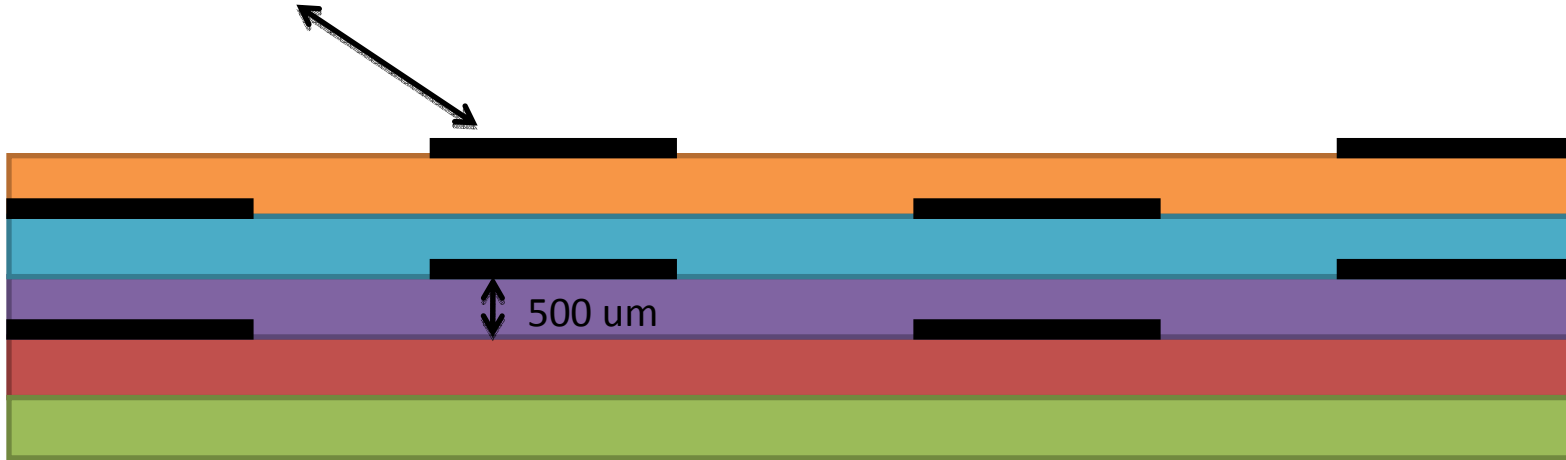


Stack-Up del PCB



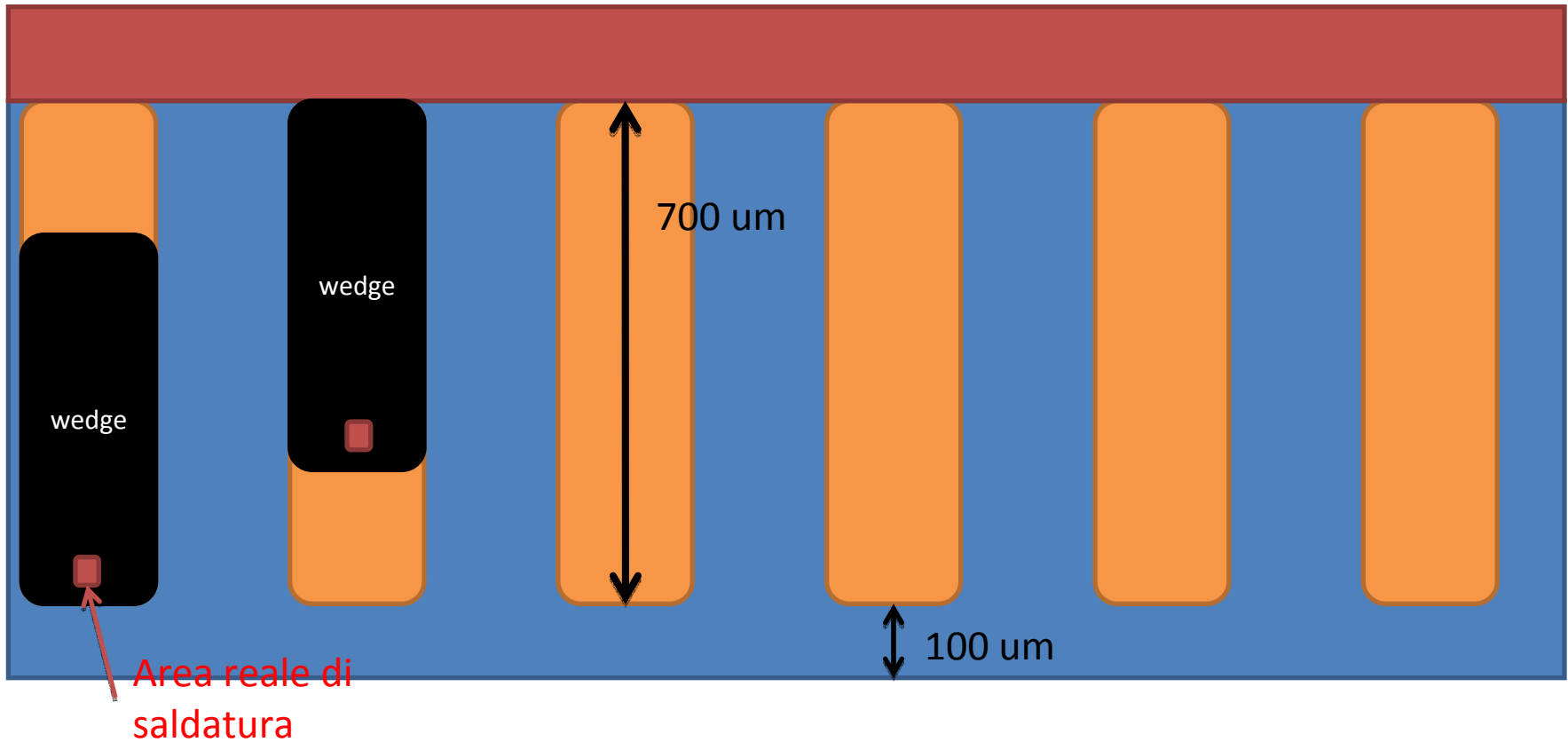
Vista frontale della zona con i connettori

Connettori P5KS



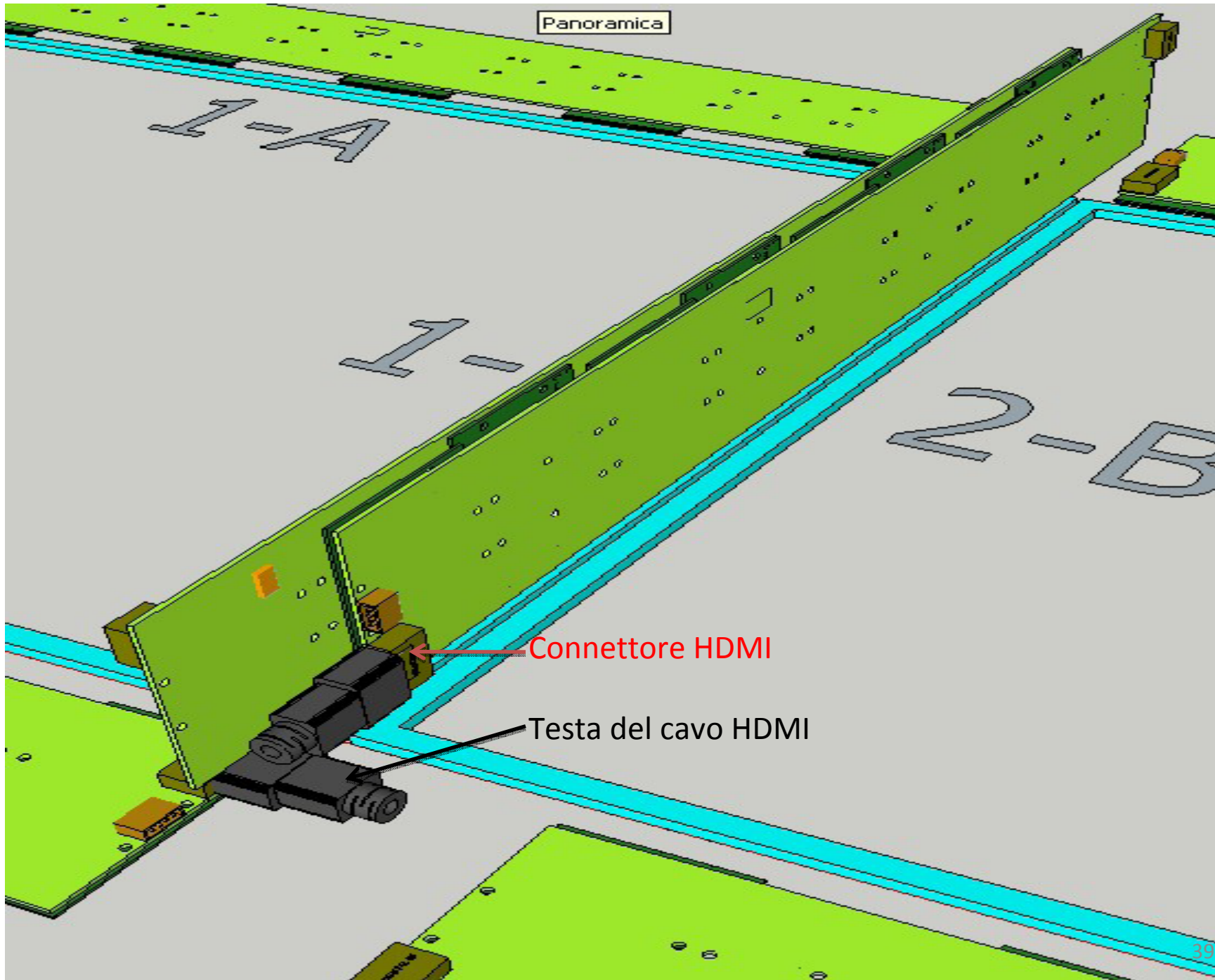
Vista in sezione della zona dei Connettori





$$(700+100) \times 4 + 800 = 4000 \text{ um} = 4\text{mm}$$

Massimo disponibile dalla macchina con la Y motorizzata





High-Definition Multimedia Interface HDMI

Nel progetto si utilizzeranno cavi hdmi di due tipi:

Type A : trasporto segnali digitali
dal VME al Front-End

5 segnali

Reset
Trigger
Clock
I2C (necessita di 2 linee)

Type B : trasporto segnali
analogici dal Front-End al VME

8 segnali

Ogni canale trasporta il contenuto
dei 128 canali serializzati di un
APV25

Table 1: APV25 features and performance

FEATURE	VALUE/DESCRIPTION/COMMENT
front end	128 channels, low noise CR-RC amplifier, 50ns shaping time
analogue pipeline	40 MS/s, 192 cells deep. Allows up to 4 μ s level 1 trigger latency, plus buffering for events awaiting readout
pipeline readout	<i>peak</i> or <i>deconvolution</i> operating modes <i>peak mode</i> : 1 sample/channel <i>deconvolution</i> : weighted sum of 3 samples gives single bunch crossing time resolution
output stage	128:1 analogue multiplexer, single differential current output
noise	peak mode: $270 + 38/\text{pF}$ deconvolution: $430 + 61/\text{pF}$
I ² C slow control I/F	programmable bias registers, operating mode, trigger latency
LVDS fast control I/F	40 MHz clock and level 1 trigger
test pulse	on-chip test pulse generator with programmable amplitude and delay
rad-hard	> 100 kGray (10 Mrads)

**Distanza dal piano di massa.
Dalla lunghezza delle piste.**

Valori del CrossTalk Massimi (L = 20.9 cm)

PCB 4 (630 um dal piano di massa)

Crosstalk interstrip : 0.12%

Crosstalk con PCB 3 : 0.09%

Crosstalk con PCB 2 : 0.06%

Crosstalk con PCB 1 : 0.04%

Crosstalk Totale 0.31%

PCB 1 (2520 um dal piano di massa)

Crosstalk interstrip : 0.13%

Crosstalk con PCB 2 : 0.12%

Crosstalk con PCB 3 : 0.09%

Crosstalk con PCB 4 : 0.04%

Crosstalk Totale 0.38%

Crosstalk per i tratti senza piano di massa : 4.5%

Simulazione Strip di maggiore lunghezza : L = 20.9 cm in PCB 2

In questo caso è anche la strip con maggiore percorrenza sotto al piano di massa

Distanza dal piano di massa 1890 um.

14.2 cm di percorrenza sotto il piano di massa.

Embedded Microstrip Impedance Calculator:

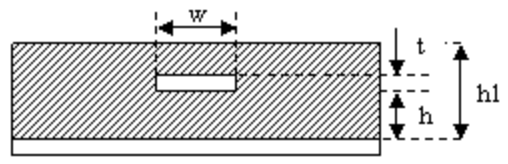
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$$\epsilon_{rp} = \epsilon_r \left(1 - \exp \left(-1.55 \frac{h_1}{h} \right) \right)$$

**Valori per tratto
sotto il piano di
massa**

Note: valid for (h1/h) greater than 1.2

Dimensional units: mm mils

w (trace width) =	0.1
t (trace thickness) =	0.02
h (trace dielectric thickness) =	1.89
h1 (overall dielectric thickness) =	3.78
er (relative dielectric constant) =	4.5
	
<input type="button" value="Calculate"/>	
Zo (Impedance, Ohms) =	136.834
Propagation Delay, Tpd (ps/cm) =	57.629
Inductance, L (nH/cm) =	7.886
Capacitance, C (pF/cm) =	0.42116

Note: 1oz = 1.4mils = 0.03556mm

Embedded Microstrip Impedance Calculator:

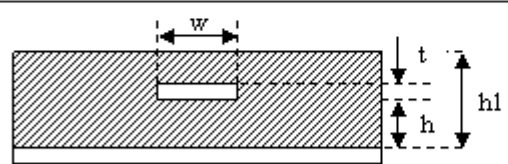
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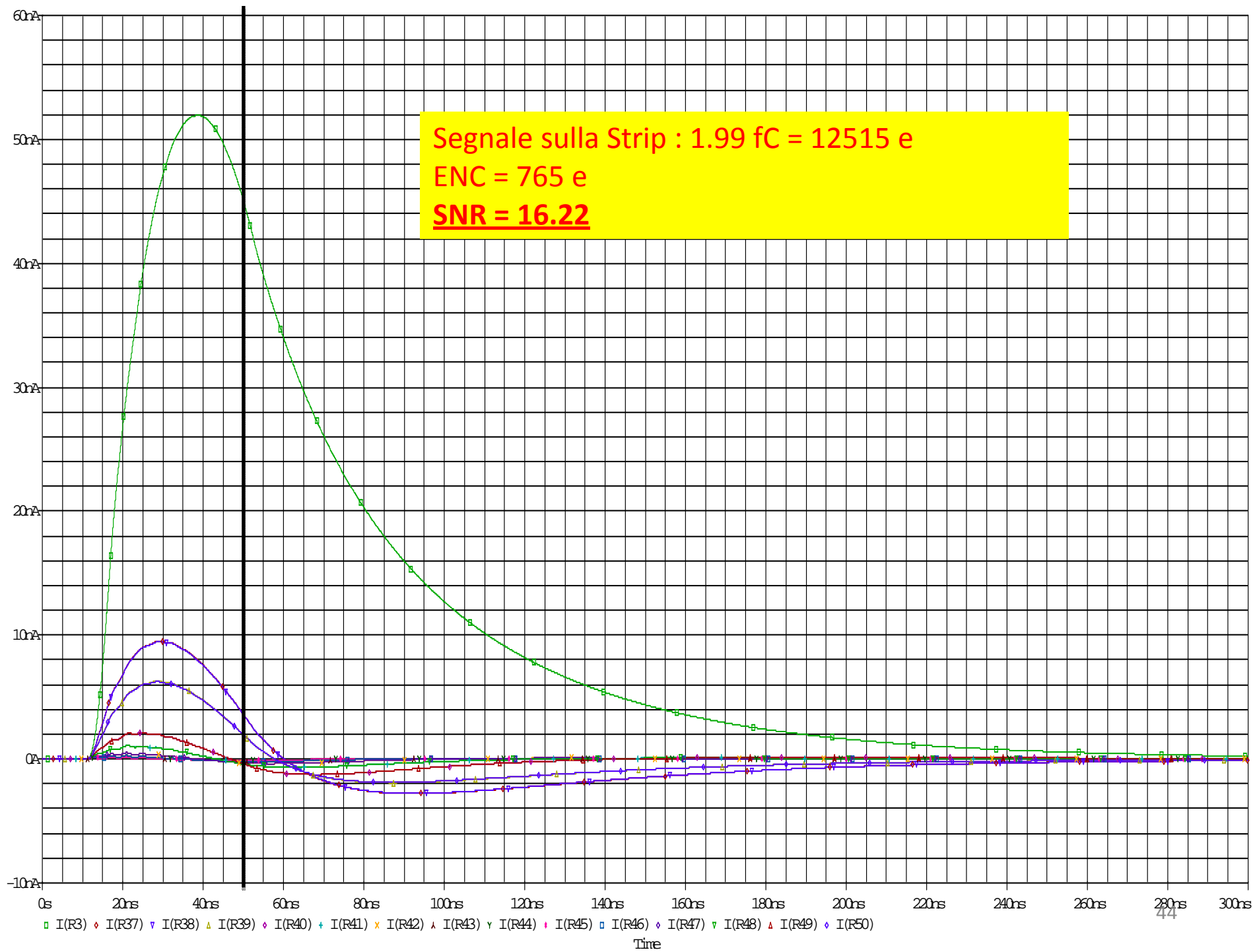
**Valori per tratto
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Note: valid for (h1/h) greater than 1.2

Dimensional units: mm mils

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h1 (overall dielectric thickness) =	1000030
er (relative dielectric constant) =	4.5
	
<input type="button" value="Calculate"/>	
Zo (Impedance, Ohms) =	570.635
Propagation Delay, Tpd (ps/cm) =	52.342
Inductance, L (nH/cm) =	29.868
Capacitance, C (pF/cm) =	0.09173

Note: 1oz = 1.4mils = 0.03556mm



**Simulazione Strip in PCB4 di lunghezza : L = 16 cm.
 Distanza minore dal piano di massa (PCB 4) 630 um.
 11.2 cm di percorrenza sotto il piano di massa.**

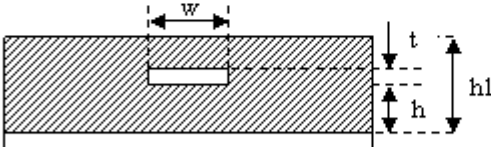
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Note: valid for (h1/h) greater than 1.2

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**Valori per tratto
sotto il piano di
massa**

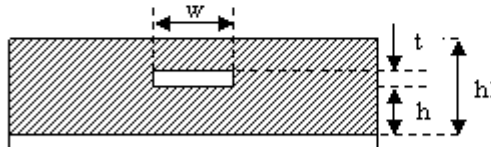
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Note: 1oz = 1.4mils = 0.03556mm

**Valori per tratto
senza il piano di
massa**

Segnale sulla Strip : 2.01 fC = 12540 e
ENC = 775 e
SNR = 16.18

